



CY96610 series is based on Cypress advanced F²MC-16FX architecture (16-bit with instruction pipeline for RISC-like performance). The CPU uses the same instruction set as the established F²MC-16LX family thus allowing for easy migration of F²MC-16LX Software to the new F²MC-16FX products. F²MC-16FX product improvements compared to the previous generation include significantly improved performance - even at the same operation frequency, reduced power consumption and faster start-up time. For high processing speed at optimized power consumption an internal PLL can be selected to supply the CPU with up to 32MHz operation frequency from an external 4MHz to 8MHz resonator. The result is a minimum instruction cycle time of 31.2ns going together with excellent EMI behavior. The emitted power is minimized by the on-chip voltage regulator that reduces the internal CPU voltage. A flexible clock tree allows selecting suitable operation frequencies for peripheral resources independent of the CPU speed.

Features

Technology

- 0.18µm CMOS

CPU

- F²MC-16FX CPU
- Optimized instruction set for controller applications (bit, byte, word and long-word data types, 23 different addressing modes, barrel shift, variety of pointers)
- 8-byte instruction queue
- Signed multiply (16-bit × 16-bit) and divide (32-bit/16-bit) instructions available

System Clock

- On-chip PLL clock multiplier (×1 to ×8, ×1 when PLL stop)
- 4MHz to 8MHz crystal oscillator (maximum frequency when using ceramic resonator depends on Q-factor)
- Up to 8MHz external clock for devices with fast clock input feature
- 32.768kHz subsystem quartz clock
- 100kHz/2MHz internal RC clock for quick and safe startup, clock stop detection function, watchdog
- Clock source selectable from mainclock oscillator, subclock oscillator and on-chip RC oscillator, independently for CPU and 2 clock domains of peripherals
- The subclock oscillator is enabled by the Boot ROM program controlled by a configuration marker after a Power or External reset
- Low Power Consumption - 13 operating modes (different Run, Sleep, Timer, Stop modes)

On-Chip Voltage Regulator

- Internal voltage regulator supports a wide MCU supply voltage range (Min=2.7V), offering low power consumption

Low Voltage Detection Function

- Reset is generated when supply voltage falls below programmable reference voltage

Code Security

- Protects Flash Memory content from unintended read-out

DMA

- Automatic transfer function independent of CPU, can be assigned freely to resources

Interrupts

- Fast Interrupt processing
- 8 programmable priority levels
- Non-Maskable Interrupt (NMI)

CAN

- Supports CAN protocol version 2.0 part A and B
- ISO16845 certified
- Bit rates up to 1Mbps
- 32 message objects
- Each message object has its own identifier mask
- Programmable FIFO mode (concatenation of message objects)
- Maskable interrupt
- Disabled Automatic Retransmission mode for Time Triggered CAN applications
- Programmable loop-back mode for self-test operation

USART

- Full duplex USARTs (SCI/LIN)
- Wide range of baud rate settings using a dedicated reload timer
- Special synchronous options for adapting to different synchronous serial protocols

- LIN functionality working either as master or slave LIN device
- Extended support for LIN-Protocol to reduce interrupt load

A/D Converter

- SAR-type
- 8/10-bit resolution
- Signals interrupt on conversion end, single conversion mode, continuous conversion mode, stop conversion mode, activation by software, external trigger, reload timers and PPGs
- Range Comparator Function

Source Clock Timers

- Three independent clock timers (23-bit RC clock timer, 23-bit Main clock timer, 17-bit Sub clock timer)

Hardware Watchdog Timer

- Hardware watchdog timer is active after reset
- Window function of Watchdog Timer is used to select the lower window limit of the watchdog interval

Reload Timers

- 16-bit wide
- Prescaler with $1/2^1$, $1/2^2$, $1/2^3$, $1/2^4$, $1/2^5$, $1/2^6$ of peripheral clock frequency
- Event count function

Free-Running Timers

- Signals an interrupt on overflow, supports timer clear upon match with Output Compare (0..4)
- Prescaler with 1, $1/2^1$, $1/2^2$, $1/2^3$, $1/2^4$, $1/2^5$, $1/2^6$, $1/2^7$, $1/2^8$ of peripheral clock frequency

Input Capture Units

- 16-bit wide
- Signals an interrupt upon external event
- Rising edge, Falling edge or Both (rising & falling) edges sensitive

Output Compare Units

- 16-bit wide
- Signals an interrupt when a match with Free-running Timer occurs
- A pair of compare registers can be used to generate an output signal

Programmable Pulse Generator

- 16-bit down counter, cycle and duty setting registers
- Can be used as 2 ×8-bit PPG
- Interrupt at trigger, counter borrow and/or duty match
- PWM operation and one-shot operation

- Internal prescaler allows 1, 1/4, 1/16, 1/64 of peripheral clock as counter clock or of selected Reload timer underflow as clock input
- Can be triggered by software or reload timer
- Can trigger ADC conversion
- Timing point capture

Quadrature Position/Revolution Counter (QPRC)

- Up/down count mode, Phase difference count mode, Count mode with direction
- 16-bit position counter
- 16-bit revolution counter
- Two 16-bit compare registers with interrupt
- Detection edge of the three external event input pins AIN, BIN and ZIN is configurable

Real Time Clock

- Operational on main oscillation (4MHz), sub oscillation (32kHz) or RC oscillation (100kHz/2MHz)
- Capable to correct oscillation deviation of Sub clock or RC oscillator clock (clock calibration)
- Read/write accessible second/minute/hour registers
- Can signal interrupts every half second/second/minute/hour/day
- Internal clock divider and prescaler provide exact 1s clock

External Interrupts

- Edge or Level sensitive
- Interrupt mask bit per channel
- Each available CAN channel RX has an external interrupt for wake-up
- Selected USART channels SIN have an external interrupt for wake-up

Non Maskable Interrupt

- Disabled after reset, can be enabled by Boot-ROM depending on ROM configuration block
- Once enabled, can not be disabled other than by reset
- High or Low level sensitive
- Pin shared with external interrupt 0

I/O Ports

- Most of the external pins can be used as general purpose I/O
- All push-pull outputs
- Bit-wise programmable as input/output or peripheral signal
- Bit-wise programmable input enable
- One input level per GPIO-pin (either Automotive or CMOS hysteresis)
- Bit-wise programmable pull-up resistor

Built-in On Chip Debugger (OCD)

- One-wire debug tool interface
- Break function:
 - Hardware break: 6 points (shared with code event)
 - Software break: 4096 points
- Event function
 - Code event: 6 points (shared with hardware break)
 - Data event: 6 points
 - Event sequencer: 2 levels + reset
- Execution time measurement function
- Trace function: 42 branches
- Security function

Flash Memory

- Dual operation flash allowing reading of one Flash bank while programming or erasing the other bank
- Command sequencer for automatic execution of programming algorithm and for supporting DMA for programming of the Flash Memory
- Supports automatic programming, Embedded Algorithm
- Write/Erase/Erase-Suspend/Resume commands
- A flag indicating completion of the automatic algorithm
- Erase can be performed on each sector individually
- Sector protection
- Flash Security feature to protect the content of the Flash
- Low voltage detection during Flash erase or write

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1. Product Lineup

| Features | | CY96610 | Remark |
|---|--|--|---|
| Product Type | | Flash Memory Product | |
| Subclock | | Subclock can be set by software | |
| Dual Operation Flash Memory | RAM | - | |
| 32.5KB + 32KB | 4KB | CY96F612R, CY96F612A | Product Options R: MCU with CAN A: MCU without CAN |
| 64.5KB + 32KB | 10KB | CY96F613R, CY96F613A | |
| 128.5KB + 32KB | 10KB | CY96F615R, CY96F615A | |
| Package | | LQFP-48 LQA048 | |
| DMA | | 2ch | |
| USART | | 3ch | LIN-USART 2/7/8 |
| | with automatic LIN-Header transmission/reception | Yes (only 1ch) | LIN-USART 2 |
| | with 16 byte RX- and TX-FIFO | No | |
| 8/10-bit A/D Converter | | 16ch | AN 0/1/3/4/6 to 10/ 12/14/16/24/25/30/31 |
| | with Data Buffer | No | |
| | with Range Comparator | Yes | |
| | with Scan Disable | No | |
| | with ADC Pulse Detection | No | |
| 16-bit Reload Timer (RLT) | | 3ch | RLT 1/3/6 |
| 16-bit Free-Running Timer (FRT) | | 4ch | FRT 0 to 3 FRT 0 to 3 does not have external clock input pin |
| 16-bit Input Capture Unit (ICU) | | 7ch (3 channels for LIN-USART) | ICU 0/1/4 to 6/9/10 (ICU 6/9/10 for LIN-USART) |
| 16-bit Output Compare Unit (OCU) | | 5ch | OCU 0/1/4/6/7 (OCU 4 for FRT clear) |
| 8/16-bit Programmable Pulse Generator (PPG) | | 8ch (16-bit) / 16ch (8-bit) | PPG 0/1/3/4/6/7/12/14 |
| | with Timing point capture | Yes | |
| | with Start delay | No | |
| | with Ramp | No | |
| Quadrature Position/Revolution Counter (QPRC) | | 2ch | QPRC 0/1 |
| CAN Interface | | 1ch | CAN 2 32 Message Buffers |
| External Interrupts (INT) | | 11ch | INT 0/2/3/4/7 to 13 |
| Non-Maskable Interrupt (NMI) | | 1ch | |
| Real Time Clock (RTC) | | 1ch | |
| I/O Ports | | 35 (Dual clock mode) 37 (Single clock mode) | |
| Clock Calibration Unit (CAL) | | 1ch | |
| Clock Output Function | | 2ch | |
| Low Voltage Detection Function | | Yes | Low voltage detection function can be disabled by software |
| Hardware Watchdog Timer | | Yes | |
| On-chip RC-oscillator | | Yes | |
| On-chip Debugger | | Yes | |

Note:

- All signals of the peripheral function in each product cannot be allocated by limiting the pins of package. It is necessary to use the port relocate function of the general I/O port according to your function use.

2. Block Diagram



3. Pin Assignment



4. Pin Description

| Pin Name | Feature | Description |
|-----------------|-----------------------|---|
| ADTG_R | ADC | Relocated A/D converter trigger input pin |
| AINn | QPRC | Quadrature Position/Revolution Counter Unit n input pin |
| ANn | ADC | A/D converter channel n input pin |
| AVcc | Supply | Analog circuits power supply pin |
| AVRH | ADC | A/D converter high reference voltage input pin |
| AVss | Supply | Analog circuits power supply pin |
| BINn | QPRC | Quadrature Position/Revolution Counter Unit n input pin |
| C | Voltage regulator | Internally regulated power supply stabilization capacitor pin |
| CKOTn | Clock Output function | Clock Output function n output pin |
| CKOTn_R | Clock Output function | Relocated Clock Output function n output pin |
| CKOTXn | Clock Output function | Clock Output function n inverted output pin |
| DEBUG I/F | OCD | On Chip Debugger input/output pin |
| INn | ICU | Input Capture Unit n input pin |
| INTn | External Interrupt | External Interrupt n input pin |
| INTn_R | External Interrupt | Relocated External Interrupt n input pin |
| INTn_R1 | External Interrupt | Relocated External Interrupt n input pin |
| MD | Core | Input pin for specifying the operating mode |
| NMI | External Interrupt | Non-Maskable Interrupt input pin |
| OUTn | OCU | Output Compare Unit n waveform output pin |
| OUTn_R | OCU | Relocated Output Compare Unit n waveform output pin |
| Pnn_m | GPIO | General purpose I/O pin |
| PPGn | PPG | Programmable Pulse Generator n output pin (16bit/8bit) |
| PPGn_B | PPG | Programmable Pulse Generator n output pin (16bit/8bit) |
| RSTX | Core | Reset input pin |
| RXn | CAN | CAN interface n RX input pin |
| SCKn | USART | USART n serial clock input/output pin |
| SCKn_R | USART | Relocated USART n serial clock input/output pin |
| SINn | USART | USART n serial data input pin |
| SINn_R | USART | Relocated USART n serial data input pin |
| SOTn | USART | USART n serial data output pin |
| SOTn_R | USART | Relocated USART n serial data output pin |
| TINn | Reload Timer | Reload Timer n event input pin |
| TOTn | Reload Timer | Reload Timer n output pin |
| TTGn | PPG | Programmable Pulse Generator n trigger input pin |
| TXn | CAN | CAN interface n TX output pin |
| V _{cc} | Supply | Power supply pin |
| V _{ss} | Supply | Power supply pin |
| X0 | Clock | Oscillator input pin |
| X0A | Clock | Subclock Oscillator input pin |
| X1 | Clock | Oscillator output pin |
| X1A | Clock | Subclock Oscillator output pin |

| Pin Name | Feature | Description |
|----------|---------|---|
| ZINn | QPRC | Quadrature Position/Revolution Counter Unit n input pin |

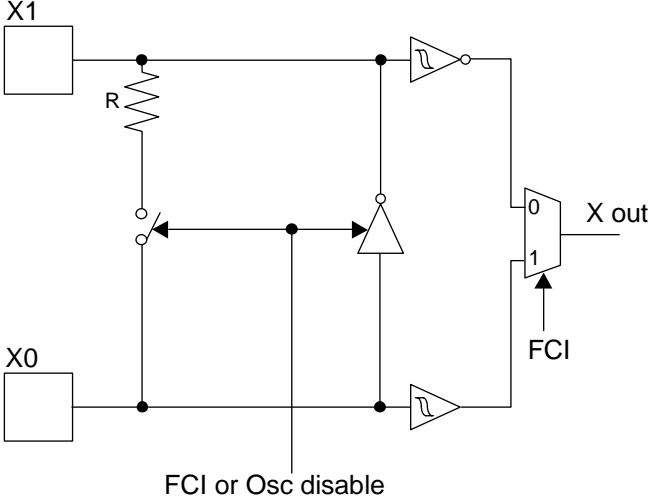
5. Pin Circuit Type

| Pin No. | I/O Circuit Type* | Pin Name |
|---------|-------------------|----------------------------------|
| 1 | Supply | AVss |
| 2 | G | AVRH |
| 3 | K | P06_3 / AN3 / PPG3 |
| 4 | K | P06_4 / AN4 / PPG4 |
| 5 | K | P06_6 / AN6 / PPG6 |
| 6 | K | P06_7 / AN7 / PPG7 |
| 7 | I | P05_0 / AN8 / SIN2 / INT3_R1 |
| 8 | K | P05_1 / AN9 / SOT2 |
| 9 | I | P05_2 / AN10 / SCK2 |
| 10 | K | P05_4 / AN12 / TOT3 / INT2_R |
| 11 | K | P05_6 / AN14 / INT4_R |
| 12 | K | P07_0 / AN16 / INT0 / NMI |
| 13 | B | P04_0 / X0A |
| 14 | B | P04_1 / X1A |
| 15 | C | MD |
| 16 | H | P17_0 |
| 17 | O | DEBUG I/F |
| 18 | M | P00_0 / INT8 / SCK7_R / PPG0_B |
| 19 | H | P00_1 / INT9 / SOT7_R / PPG1_B |
| 20 | M | P00_2 / INT10 / SIN7_R |
| 21 | H | P00_4 / INT12 / SOT8_R / PPG12_B |
| 22 | M | P00_5 / INT13 / SIN8_R / PPG14_B |
| 23 | M | P00_3 / INT11 / SCK8_R / PPG3_B |
| 24 | H | P01_0 / TIN1 / CKOT1 / OUT0_R |
| 25 | H | P01_1 / TOT1 / CKOTX1 / OUT1_R |
| 26 | H | P01_4 / PPG4_B |
| 27 | M | P01_5 / SIN2_R / INT7_R |
| 28 | H | P01_6 / SOT2_R / PPG6_B |
| 29 | M | P01_7 / SCK2_R / PPG7_B |
| 30 | H | P02_0 / PPG12 / CKOT1_R |
| 31 | H | P02_2 / ZIN0 / PPG14 / CKOT0_R |
| 32 | H | P02_4 / AIN0 / IN0 / TTG0 |

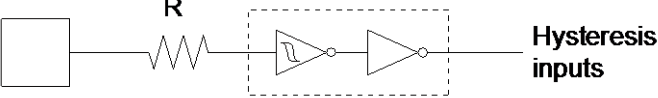
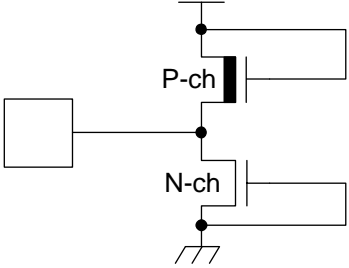
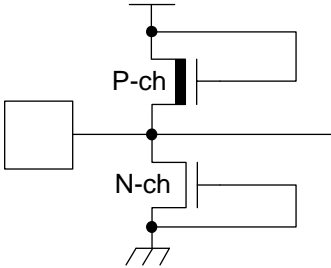
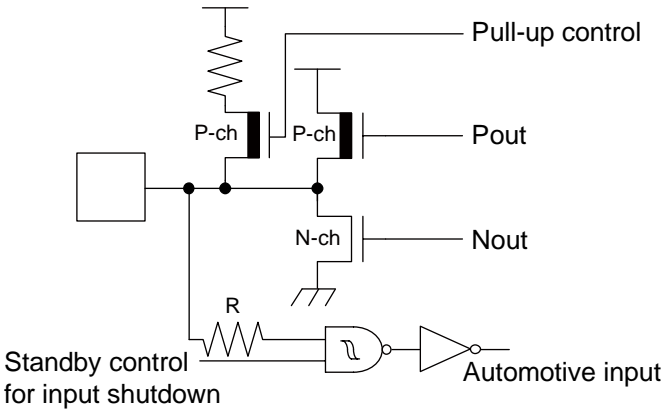
| Pin No. | I/O Circuit Type* | Pin Name |
|---------|-------------------|--|
| 33 | C | RSTX |
| 34 | A | X1 |
| 35 | A | X0 |
| 36 | Supply | Vss |
| 37 | Supply | Vcc |
| 38 | F | C |
| 39 | H | P02_5 / BIN0 / IN1 / TTG1 / ADTG_R |
| 40 | K | P03_0 / AIN1 / IN4 / TTG4 / TTG12 / AN24 |
| 41 | K | P03_1 / BIN1 / IN5 / TTG5 / TTG13 / AN25 |
| 42 | M | P03_2 / INT10_R / RX2 |
| 43 | H | P03_3 / TX2 |
| 44 | K | P03_6 / ZIN1 / OUT6 / AN30 |
| 45 | K | P03_7 / OUT7 / AN31 |
| 46 | K | P06_0 / AN0 / PPG0 |
| 47 | K | P06_1 / AN1 / PPG1 |
| 48 | Supply | AVcc |

*: See [I/O Circuit Type](#) for details on the I/O circuit types.

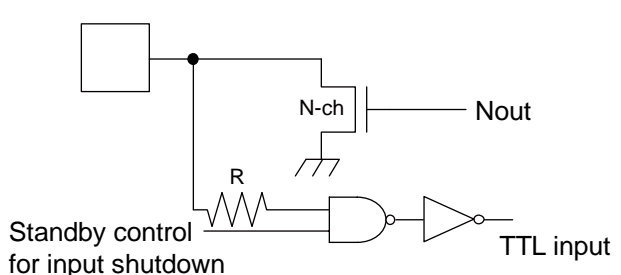
6. I/O Circuit Type

| Type | Circuit | Remarks |
|------|---|--|
| A |  | <p>High-speed oscillation circuit:</p> <ul style="list-style-type: none"> ■ Programmable between oscillation mode (external crystal or resonator connected to X0/X1 pins) and Fast external Clock Input (FCI) mode (external clock connected to X0 pin) ■ Feedback resistor = approx. 1.0MΩ ■ The amplitude: 1.8V±0.15V to operate by the internal supply voltage |

| Type | Circuit | Remarks |
|------|---|--|
| B | <p>The diagram illustrates a low-speed oscillation circuit shared with GPIO functionality. It features two identical sections. Each section includes a pull-up resistor connected to a supply rail. Below the resistor are two P-channel MOSFETs (P-ch) and one N-channel MOSFET (N-ch). The top P-ch MOSFET is labeled 'Pout', and the N-ch MOSFET is labeled 'Nout'. A 'Pull-up control' signal is connected to the gates of the P-ch MOSFETs. A 'Standby control for input shutdown' signal is connected to the gates of the P-ch MOSFETs and to a resistor 'R'. The other end of resistor 'R' is connected to an 'Automotive input' through an AND gate and an inverter. The oscillator circuit consists of two cross-coupled inverters. The inputs of these inverters are labeled 'X1A' and 'X0A'. A feedback resistor 'R' is connected between the outputs of the two inverters. The output of the oscillator is connected to an 'X out' multiplexer, which has two inputs labeled '0' and '1'. The '1' input is selected by an 'FCI' signal. A control signal labeled 'FCI or Osc disable' is connected to the gates of the P-ch MOSFETs and to the 'FCI' input of the multiplexer. The bottom P-ch MOSFET is labeled 'Pout', and the N-ch MOSFET is labeled 'Nout'. A 'Pull-up control' signal is connected to the gates of the P-ch MOSFETs. A 'Standby control for input shutdown' signal is connected to the gates of the P-ch MOSFETs and to a resistor 'R'. The other end of resistor 'R' is connected to an 'Automotive input' through an AND gate and an inverter.</p> | <p>Low-speed oscillation circuit shared with GPIO functionality:</p> <ul style="list-style-type: none"> ■ Feedback resistor = approx. 5.0MΩ ■ GPIO functionality selectable (CMOS level output ($I_{OL} = 4\text{mA}$, $I_{OH} = -4\text{mA}$), Automotive input with input shutdown function and programmable pull-up resistor) |

| Type | Circuit | Remarks |
|------|---|--|
| C |  | <p>CMOS hysteresis input pin</p> |
| F |  | <p>Power supply input protection circuit</p> |
| G |  | <ul style="list-style-type: none"> ■ A/D converter ref+ (AVRH) power supply input pin with protection circuit ■ Without protection circuit against V_{CC} for pins AVRH |
| H |  | <ul style="list-style-type: none"> ■ CMOS level output ■ ($I_{OL} = 4mA$, $I_{OH} = -4mA$) ■ Automotive input with input shutdown function ■ Programmable pull-up resistor |

| Type | Circuit | Remarks |
|------|--|---|
| I | <p>Standby control for input shutdown</p> <p>Pull-up control</p> <p>Pout</p> <p>Nout</p> <p>Hysteresis input</p> <p>Analog input</p> | <ul style="list-style-type: none"> ■ CMOS level output ■ ($I_{OL} = 4\text{mA}$, $I_{OH} = -4\text{mA}$) ■ CMOS hysteresis input with input shutdown function ■ Programmable pull-up resistor ■ Analog input |
| K | <p>Standby control for input shutdown</p> <p>Pull-up control</p> <p>Pout</p> <p>Nout</p> <p>Automotive input</p> <p>Analog input</p> | <ul style="list-style-type: none"> ■ CMOS level output ■ ($I_{OL} = 4\text{mA}$, $I_{OH} = -4\text{mA}$) ■ Automotive input with input shutdown function ■ Programmable pull-up resistor ■ Analog input |
| M | <p>Standby control for input shutdown</p> <p>Pull-up control</p> <p>Pout</p> <p>Nout</p> <p>Hysteresis input</p> | <ul style="list-style-type: none"> ■ CMOS level output ■ ($I_{OL} = 4\text{mA}$, $I_{OH} = -4\text{mA}$) ■ CMOS hysteresis input with input shutdown function ■ Programmable pull-up resistor |

| Type | Circuit | Remarks |
|------|---|--|
| O |  | <ul style="list-style-type: none"> ■ Open-drain I/O ■ Output 25mA, Vcc = 2.7V ■ TTL input |

7. Memory Map

| | |
|--|--------------------|
| FF:FFFF _H | USER ROM*1 |
| DE:0000 _H DD:FFFF _H | Reserved |
| 10:0000 _H | Boot-ROM |
| 0F:C000 _H | Peripheral |
| 0E:9000 _H | Reserved |
| 01:0000 _H | ROM/RAM MIRROR |
| 00:8000 _H | Internal RAM bank0 |
| RAMSTART0*2 | Reserved |
| 00:0C00 _H | Peripheral |
| 00:0380 _H | GPR*3 |
| 00:0180 _H | DMA |
| 00:0100 _H | Reserved |
| 00:00F0 _H | Reserved |
| 00:0000 _H | Peripheral |

*1: For details about USER ROM area, see “
User ROM Memory Map for Flash Devices” on the following pages.

*2: For RAMSTART addresses, see the table on the next page.

*3: Unused GPR banks can be used as RAM area.

GPR: General-Purpose Register

The DMA area is only available if the device contains the corresponding resource.

The available RAM and ROM area depends on the device.

8. RAMstart Addresses

| Devices | Bank 0 RAM Size | RAMSTART0 |
|--------------------|--------------------|----------------------|
| CY96F612 | 4KB | 00:7200 _H |
| CY96F613, CY96F615 | 10KB | 00:5A00 _H |

9. User ROM Memory Map for Flash Devices

| | | CY96F612 | CY96F613 | CY96F615 | | | | | |
|----------------------|---------------------------|-----------------------------|-----------------------------|------------------------------|-------------------|-----------|-----------|-----------|-------------------|
| CPU mode address | Flash memory mode address | Flash size 32.5KB + 32KB | Flash size 64.5KB + 32KB | Flash size 128.5KB + 32KB | | | | | |
| FF:FFFF _H | 3F:FFFF _H | SA39 - 32KB | SA39 - 64KB | SA39 - 64KB | Bank A of Flash A | | | | |
| FF:8000 _H | 3F:8000 _H | | | | | | | | |
| FF:7FFF _H | 3F:7FFF _H | | | | | | | | |
| FF:0000 _H | 3F:0000 _H | | | | | | | | |
| FE:FFFF _H | 3E:FFFF _H | | | | | | | | |
| FE:0000 _H | 3E:0000 _H | Reserved | Reserved | Reserved | | | | | |
| FD:FFFF _H | | | | | | | | | |
| DF:A000 _H | | | | | | | | | |
| DF:9FFF _H | 1F:9FFF _H | | | | | SA4 - 8KB | SA4 - 8KB | SA4 - 8KB | Bank B of Flash A |
| DF:8000 _H | 1F:8000 _H | | | | | SA3 - 8KB | SA3 - 8KB | SA3 - 8KB | |
| DF:7FFF _H | 1F:7FFF _H | SA2 - 8KB | SA2 - 8KB | SA2 - 8KB | | | | | |
| DF:6000 _H | 1F:6000 _H | SA1 - 8KB | SA1 - 8KB | SA1 - 8KB | | | | | |
| DF:5FFF _H | 1F:5FFF _H | | | | | | | | |
| DF:4000 _H | 1F:4000 _H | | | | Bank A of Flash A | | | | |
| DF:3FFF _H | 1F:3FFF _H | SAS - 512B* | SAS - 512B* | SAS - 512B* | | | | | |
| DF:2000 _H | 1F:2000 _H | | | | | | | | |
| DF:1FFF _H | 1F:1FFF _H | | | | Bank A of Flash A | | | | |
| DF:0000 _H | 1F:0000 _H | Reserved | Reserved | Reserved | | | | | |
| DE:FFFF _H | | | | | | | | | |
| DE:0000 _H | | | | | | | | | |

*: Physical address area of SAS-512B is from DF:0000_H to DF:01FF_H.

Others (from DF:0200_H to DF:1FFF_H) is mirror area of SAS-512B.

Sector SAS contains the ROM configuration block RCBA at CPU address DF:0000_H -DF:01FF_H.

SAS can not be used for E²PROM emulation.

10. Serial Programming Communication Interface

USART pins for Flash serial programming (MD = 0, DEBUG I/F = 0, Serial Communication mode)

| CY96610 | | |
|------------|--------------|-----------------|
| Pin Number | USART Number | Normal Function |
| 7 | USART2 | SIN2 |
| 8 | | SOT2 |
| 9 | | SCK2 |
| 20 | USART7 | SIN7_R |
| 19 | | SOT7_R |
| 18 | | SCK7_R |
| 22 | USART8 | SIN8_R |
| 21 | | SOT8_R |
| 23 | | SCK8_R |

11. Interrupt Vector Table

| Vector Number | Offset in Vector Table | Vector Name | Cleared by DMA | Index in ICR to Program | Description |
|---------------|------------------------|-------------|----------------|-------------------------|---------------------------------|
| 0 | 3FC _H | CALLV0 | No | - | CALLV instruction |
| 1 | 3F8 _H | CALLV1 | No | - | CALLV instruction |
| 2 | 3F4 _H | CALLV2 | No | - | CALLV instruction |
| 3 | 3F0 _H | CALLV3 | No | - | CALLV instruction |
| 4 | 3EC _H | CALLV4 | No | - | CALLV instruction |
| 5 | 3E8 _H | CALLV5 | No | - | CALLV instruction |
| 6 | 3E4 _H | CALLV6 | No | - | CALLV instruction |
| 7 | 3E0 _H | CALLV7 | No | - | CALLV instruction |
| 8 | 3DC _H | RESET | No | - | Reset vector |
| 9 | 3D8 _H | INT9 | No | - | INT9 instruction |
| 10 | 3D4 _H | EXCEPTION | No | - | Undefined instruction execution |
| 11 | 3D0 _H | NMI | No | - | Non-Maskable Interrupt |
| 12 | 3CC _H | DLY | No | 12 | Delayed Interrupt |
| 13 | 3C8 _H | RC_TIMER | No | 13 | RC Clock Timer |
| 14 | 3C4 _H | MC_TIMER | No | 14 | Main Clock Timer |
| 15 | 3C0 _H | SC_TIMER | No | 15 | Sub Clock Timer |
| 16 | 3BC _H | LVDI | No | 16 | Low Voltage Detector |
| 17 | 3B8 _H | EXTINT0 | Yes | 17 | External Interrupt 0 |
| 18 | 3B4 _H | - | - | 18 | Reserved |
| 19 | 3B0 _H | EXTINT2 | Yes | 19 | External Interrupt 2 |
| 20 | 3AC _H | EXTINT3 | Yes | 20 | External Interrupt 3 |
| 21 | 3A8 _H | EXTINT4 | Yes | 21 | External Interrupt 4 |
| 22 | 3A4 _H | - | - | 22 | Reserved |
| 23 | 3A0 _H | - | - | 23 | Reserved |
| 24 | 39C _H | EXTINT7 | Yes | 24 | External Interrupt 7 |
| 25 | 398 _H | EXTINT8 | Yes | 25 | External Interrupt 8 |
| 26 | 394 _H | EXTINT9 | Yes | 26 | External Interrupt 9 |
| 27 | 390 _H | EXTINT10 | Yes | 27 | External Interrupt 10 |
| 28 | 38C _H | EXTINT11 | Yes | 28 | External Interrupt 11 |
| 29 | 388 _H | EXTINT12 | Yes | 29 | External Interrupt 12 |
| 30 | 384 _H | EXTINT13 | Yes | 30 | External Interrupt 13 |
| 31 | 380 _H | - | - | 31 | Reserved |
| 32 | 37C _H | - | - | 32 | Reserved |
| 33 | 378 _H | - | - | 33 | Reserved |
| 34 | 374 _H | - | - | 34 | Reserved |
| 35 | 370 _H | CAN2 | No | 35 | CAN Controller 2 |
| 36 | 36C _H | - | - | 36 | Reserved |
| 37 | 368 _H | - | - | 37 | Reserved |
| 38 | 364 _H | PPG0 | Yes | 38 | Programmable Pulse Generator 0 |
| 39 | 360 _H | PPG1 | Yes | 39 | Programmable Pulse Generator 1 |

| Vector Number | Offset in Vector Table | Vector Name | Cleared by DMA | Index in ICR to Program | Description |
|---------------|------------------------|-------------|----------------|-------------------------|---------------------------------|
| 40 | 35C _H | - | - | 40 | Reserved |
| 41 | 358 _H | PPG3 | Yes | 41 | Programmable Pulse Generator 3 |
| 42 | 354 _H | PPG4 | Yes | 42 | Programmable Pulse Generator 4 |
| 43 | 350 _H | - | - | 43 | Reserved |
| 44 | 34C _H | PPG6 | Yes | 44 | Programmable Pulse Generator 6 |
| 45 | 348 _H | PPG7 | Yes | 45 | Programmable Pulse Generator 7 |
| 46 | 344 _H | - | - | 46 | Reserved |
| 47 | 340 _H | - | - | 47 | Reserved |
| 48 | 33C _H | - | - | 48 | Reserved |
| 49 | 338 _H | - | - | 49 | Reserved |
| 50 | 334 _H | PPG12 | Yes | 50 | Programmable Pulse Generator 12 |
| 51 | 330 _H | - | - | 51 | Reserved |
| 52 | 32C _H | PPG14 | Yes | 52 | Programmable Pulse Generator 14 |
| 53 | 328 _H | - | - | 53 | Reserved |
| 54 | 324 _H | - | - | 54 | Reserved |
| 55 | 320 _H | - | - | 55 | Reserved |
| 56 | 31C _H | - | - | 56 | Reserved |
| 57 | 318 _H | - | - | 57 | Reserved |
| 58 | 314 _H | - | - | 58 | Reserved |
| 59 | 310 _H | RLT1 | Yes | 59 | Reload Timer 1 |
| 60 | 30C _H | - | - | 60 | Reserved |
| 61 | 308 _H | RLT3 | Yes | 61 | Reload Timer 3 |
| 62 | 304 _H | - | - | 62 | Reserved |
| 63 | 300 _H | - | - | 63 | Reserved |
| 64 | 2FC _H | RLT6 | Yes | 64 | Reload Timer 6 |
| 65 | 2F8 _H | ICU0 | Yes | 65 | Input Capture Unit 0 |
| 66 | 2F4 _H | ICU1 | Yes | 66 | Input Capture Unit 1 |
| 67 | 2F0 _H | - | - | 67 | Reserved |
| 68 | 2EC _H | - | - | 68 | Reserved |
| 69 | 2E8 _H | ICU4 | Yes | 69 | Input Capture Unit 4 |
| 70 | 2E4 _H | ICU5 | Yes | 70 | Input Capture Unit 5 |
| 71 | 2E0 _H | ICU6 | Yes | 71 | Input Capture Unit 6 |
| 72 | 2DC _H | - | - | 72 | Reserved |
| 73 | 2D8 _H | - | - | 73 | Reserved |
| 74 | 2D4 _H | ICU9 | Yes | 74 | Input Capture Unit 9 |
| 75 | 2D0 _H | ICU10 | Yes | 75 | Input Capture Unit 10 |
| 76 | 2CC _H | - | - | 76 | Reserved |
| 77 | 2C8 _H | OCU0 | Yes | 77 | Output Compare Unit 0 |
| 78 | 2C4 _H | OCU1 | Yes | 78 | Output Compare Unit 1 |
| 79 | 2C0 _H | - | - | 79 | Reserved |
| 80 | 2BC _H | - | - | 80 | Reserved |

| Vector Number | Offset in Vector Table | Vector Name | Cleared by DMA | Index in ICR to Program | Description |
|---------------|------------------------|-------------|----------------|-------------------------|------------------------|
| 81 | 2B8 _H | OCU4 | Yes | 81 | Output Compare Unit 4 |
| 82 | 2B4 _H | - | - | 82 | Reserved |
| 83 | 2B0 _H | OCU6 | Yes | 83 | Output Compare Unit 6 |
| 84 | 2AC _H | OCU7 | Yes | 84 | Output Compare Unit 7 |
| 85 | 2A8 _H | - | - | 85 | Reserved |
| 86 | 2A4 _H | - | - | 86 | Reserved |
| 87 | 2A0 _H | - | - | 87 | Reserved |
| 88 | 29C _H | - | - | 88 | Reserved |
| 89 | 298 _H | FRT0 | Yes | 89 | Free-Running Timer 0 |
| 90 | 294 _H | FRT1 | Yes | 90 | Free-Running Timer 1 |
| 91 | 290 _H | FRT2 | Yes | 91 | Free-Running Timer 2 |
| 92 | 28C _H | FRT3 | Yes | 92 | Free-Running Timer 3 |
| 93 | 288 _H | RTC0 | No | 93 | Real Time Clock |
| 94 | 284 _H | CAL0 | No | 94 | Clock Calibration Unit |
| 95 | 280 _H | - | - | 95 | Reserved |
| 96 | 27C _H | - | - | 96 | Reserved |
| 97 | 278 _H | - | - | 97 | Reserved |
| 98 | 274 _H | ADC0 | Yes | 98 | A/D Converter 0 |
| 99 | 270 _H | - | - | 99 | Reserved |
| 100 | 26C _H | - | - | 100 | Reserved |
| 101 | 268 _H | - | - | 101 | Reserved |
| 102 | 264 _H | - | - | 102 | Reserved |
| 103 | 260 _H | - | - | 103 | Reserved |
| 104 | 25C _H | - | - | 104 | Reserved |
| 105 | 258 _H | LINR2 | Yes | 105 | LIN USART 2 RX |
| 106 | 254 _H | LINT2 | Yes | 106 | LIN USART 2 TX |
| 107 | 250 _H | - | - | 107 | Reserved |
| 108 | 24C _H | - | - | 108 | Reserved |
| 109 | 248 _H | - | - | 109 | Reserved |
| 110 | 244 _H | - | - | 110 | Reserved |
| 111 | 240 _H | - | - | 111 | Reserved |
| 112 | 23C _H | - | - | 112 | Reserved |
| 113 | 238 _H | - | - | 113 | Reserved |
| 114 | 234 _H | - | - | 114 | Reserved |
| 115 | 230 _H | LINR7 | Yes | 115 | LIN USART 7 RX |
| 116 | 22C _H | LINT7 | Yes | 116 | LIN USART 7 TX |
| 117 | 228 _H | LINR8 | Yes | 117 | LIN USART 8 RX |
| 118 | 224 _H | LINT8 | Yes | 118 | LIN USART 8 TX |
| 119 | 220 _H | - | - | 119 | Reserved |
| 120 | 21C _H | - | - | 120 | Reserved |
| 121 | 218 _H | - | - | 121 | Reserved |

| Vector Number | Offset in Vector Table | Vector Name | Cleared by DMA | Index in ICR to Program | Description |
|---------------|------------------------|-------------|----------------|-------------------------|------------------------------------|
| 122 | 214 _H | - | - | 122 | Reserved |
| 123 | 210 _H | - | - | 123 | Reserved |
| 124 | 20C _H | - | - | 124 | Reserved |
| 125 | 208 _H | - | - | 125 | Reserved |
| 126 | 204 _H | - | - | 126 | Reserved |
| 127 | 200 _H | - | - | 127 | Reserved |
| 128 | 1FC _H | - | - | 128 | Reserved |
| 129 | 1F8 _H | - | - | 129 | Reserved |
| 130 | 1F4 _H | - | - | 130 | Reserved |
| 131 | 1F0 _H | - | - | 131 | Reserved |
| 132 | 1EC _H | - | - | 132 | Reserved |
| 133 | 1E8 _H | FLASHA | Yes | 133 | Flash memory A interrupt |
| 134 | 1E4 _H | - | - | 134 | Reserved |
| 135 | 1E0 _H | - | - | 135 | Reserved |
| 136 | 1DC _H | - | - | 136 | Reserved |
| 137 | 1D8 _H | QPRC0 | Yes | 137 | Quad Position/Revolution counter 0 |
| 138 | 1D4 _H | QPRC1 | Yes | 138 | Quad Position/Revolution counter 1 |
| 139 | 1D0 _H | ADCRC0 | No | 139 | A/D Converter 0 - Range Comparator |
| 140 | 1CC _H | - | - | 140 | Reserved |
| 141 | 1C8 _H | - | - | 141 | Reserved |
| 142 | 1C4 _H | - | - | 142 | Reserved |
| 143 | 1C0 _H | - | - | 143 | Reserved |

12. Handling Precautions

Any semiconductor devices have inherently a certain rate of failure. The possibility of failure is greatly affected by the conditions in which they are used (circuit conditions, environmental conditions, etc.). This page describes precautions that must be observed to minimize the chance of failure and to obtain higher reliability from your Cypress semiconductor devices.

12.1 Precautions for Product Design

This section describes precautions when designing electronic equipment using semiconductor devices.

■ Absolute Maximum Ratings

Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of certain established limits, called absolute maximum ratings. Do not exceed these ratings.

■ Recommended Operating Conditions

Recommended operating conditions are normal operating ranges for the semiconductor device. All the device's electrical characteristics are warranted when operated within these ranges.

Always use semiconductor devices within the recommended operating conditions. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their sales representative beforehand.

■ Processing and Protection of Pins

These precautions must be followed when handling the pins which connect semiconductor devices to power supply and input/output functions.

1. Preventing Over-Voltage and Over-Current Conditions

Exposure to voltage or current levels in excess of maximum ratings at any pin is likely to cause deterioration within the device, and in extreme cases leads to permanent damage of the device. Try to prevent such overvoltage or over-current conditions at the design stage.

2. Protection of Output Pins

Shorting of output pins to supply pins or other output pins, or connection to large capacitance can cause large current flows. Such conditions if present for extended periods of time can damage the device. Therefore, avoid this type of connection.

3. Handling of Unused Input Pins

Unconnected input pins with very high impedance levels can adversely affect stability of operation. Such pins should be connected through an appropriate resistance to a power supply pin or ground pin.

■ Latch-up

Semiconductor devices are constructed by the formation of P-type and N-type areas on a substrate. When subjected to abnormally high voltages, internal parasitic PNP junctions (called thyristor structures) may be formed, causing large current levels in excess of several hundred mA to flow continuously at the power supply pin. This condition is called latch-up.

CAUTION:

The occurrence of latch-up not only causes loss of reliability in the semiconductor device, but can cause injury or damage from high heat, smoke or flame. To prevent this from happening, do the following:

1. *Be sure that voltages applied to pins do not exceed the absolute maximum ratings. This should include attention to abnormal noise, surge levels, etc.*
2. *Be sure that abnormal current flows do not occur during the power-on sequence.*

■ Observance of Safety Regulations and Standards

Most countries in the world have established standards and regulations regarding safety, protection from electromagnetic interference, etc. Customers are requested to observe applicable regulations and standards in the design of products.

■ Fail-Safe Design

Any semiconductor devices have inherently a certain rate of failure. You must protect against injury, damage or loss from such failures by incorporating safety design measures into your facility and equipment such as redundancy, fire protection, and prevention of over-current levels and other abnormal operating conditions.

■ Precautions Related to Usage of Devices

Cypress semiconductor devices are intended for use in standard applications (computers, office automation and other office equipment, industrial, communications, and measurement equipment, personal or household devices, etc.).

CAUTION:

Customers considering the use of our products in special applications where failure or abnormal operation may directly affect human lives or cause physical injury or property damage, or where extremely high levels of reliability are demanded (such as aerospace systems, atomic energy controls, sea floor repeaters, vehicle operating controls, medical devices for life support, etc.) are requested to consult with sales representatives before such use. The company will not be responsible for damages arising from such use without prior approval.

12.2 Precautions for Package Mounting

Package mounting may be either lead insertion type or surface mount type. In either case, for heat resistance during soldering, you should only mount under Cypress's recommended conditions. For detailed information about mount conditions, contact your sales representative.

■ Lead Insertion Type

Mounting of lead insertion type packages onto printed circuit boards may be done by two methods: direct soldering on the board, or mounting by using a socket.

Direct mounting onto boards normally involves processes for inserting leads into through-holes on the board and using the flow soldering (wave soldering) method of applying liquid solder. In this case, the soldering process usually causes leads to be subjected to thermal stress in excess of the absolute ratings for storage temperature. Mounting processes should conform to Cypress recommended mounting conditions.

If socket mounting is used, differences in surface treatment of the socket contacts and IC lead surfaces can lead to contact deterioration after long periods. For this reason it is recommended that the surface treatment of socket contacts and IC leads be verified before mounting.

■ Surface Mount Type

Surface mount packaging has longer and thinner leads than lead-insertion packaging, and therefore leads are more easily deformed or bent. The use of packages with higher pin counts and narrower pin pitch results in increased susceptibility to open connections caused by deformed pins, or shorting due to solder bridges.

You must use appropriate mounting techniques. Cypress recommends the solder reflow method, and has established a ranking of mounting conditions for each product. Users are advised to mount packages in accordance with Cypress ranking of recommended conditions.

■ Lead-Free Packaging**CAUTION:**

When ball grid array (BGA) packages with Sn-Ag-Cu balls are mounted using Sn-Pb eutectic soldering, junction strength may be reduced under some conditions of use.

■ Storage of Semiconductor Devices

Because plastic chip packages are formed from plastic resins, exposure to natural environmental conditions will cause absorption of moisture. During mounting, the application of heat to a package that has absorbed moisture can cause surfaces to peel, reducing moisture resistance and causing packages to crack. To prevent, do the following:

1. Avoid exposure to rapid temperature changes, which cause moisture to condense inside the product. Store products in locations where temperature changes are slight.
2. Use dry boxes for product storage. Products should be stored below 70% relative humidity, and at temperatures between 5°C and 30°C. When you open Dry Package that recommends humidity 40% to 70% relative humidity.
3. When necessary, Cypress packages semiconductor devices in highly moisture-resistant aluminum laminate bags, with a silica gel desiccant. Devices should be sealed in their aluminum laminate bags for storage.
4. Avoid storing packages where they are exposed to corrosive gases or high levels of dust.

■ Baking

Packages that have absorbed moisture may be de-moisturized by baking (heat drying). Follow the Cypress recommended conditions for baking.

Condition: 125°C/24 h

■ Static Electricity

Because semiconductor devices are particularly susceptible to damage by static electricity, you must take the following precautions:

1. Maintain relative humidity in the working environment between 40% and 70%. Use of an apparatus for ion generation may be needed to remove electricity.
2. Electrically ground all conveyors, solder vessels, soldering irons and peripheral equipment.
3. Eliminate static body electricity by the use of rings or bracelets connected to ground through high resistance (on the level of 1 MΩ). Wearing of conductive clothing and shoes, use of conductive floor mats and other measures to minimize shock loads is recommended.
4. Ground all fixtures and instruments, or protect with anti-static measures.
5. Avoid the use of styro foam or other highly static-prone materials for storage of completed board assemblies.

12.3 Precautions for Use Environment

Reliability of semiconductor devices depends on ambient temperature and other conditions as described above.

For reliable performance, do the following:

1. Humidity

Prolonged use in high humidity can lead to leakage in devices as well as printed circuit boards. If high humidity levels are anticipated, consider anti-humidity processing.

2. Discharge of Static Electricity

When high-voltage charges exist close to semiconductor devices, discharges can cause abnormal operation. In such cases, use anti-static measures or processing to prevent discharges.

3. Corrosive Gases, Dust, or Oil

Exposure to corrosive gases or contact with dust or oil may lead to chemical reactions that will adversely affect the device. If you use devices in such conditions, consider ways to prevent such exposure or to protect the devices.

4. Radiation, Including Cosmic Radiation

Most devices are not designed for environments involving exposure to radiation or cosmic radiation. Users should provide shielding as appropriate.

5. Smoke, Flame

CAUTION:

Plastic molded devices are flammable, and therefore should not be used near combustible substances. If devices begin to smoke or burn, there is danger of the release of toxic gases.

Customers considering the use of Cypress products in other special environmental conditions should consult with sales representatives.

13. Handling Devices

Special Care is Required for the Following when Handling the Device:

- Latch-up prevention
- Unused pins handling
- External clock usage
- Notes on PLL clock mode operation
- Power supply pins (V_{CC}/V_{SS})
- Crystal oscillator and ceramic resonator circuit
- Turn on sequence of power supply to A/D converter and analog inputs
- Pin handling when not using the A/D converter
- Notes on Power-on
- Stabilization of power supply voltage
- Serial communication
- Mode Pin (MD)

13.1 Latch-Up Prevention

CMOS IC chips may suffer latch-up under the following conditions:

- A voltage higher than V_{CC} or lower than V_{SS} is applied to an input or output pin.
- A voltage higher than the rated voltage is applied between V_{CC} pins and V_{SS} pins.
- The AV_{CC} power supply is applied before the V_{CC} voltage.

Latch-up may increase the power supply current dramatically, causing thermal damages to the device.

For the same reason, extra care is required to not let the analog power-supply voltage (AV_{CC} , $AVRH$) exceed the digital power-supply voltage.

13.2 Unused Pins Handling

Unused input pins can be left open when the input is disabled (corresponding bit of Port Input Enable register $PIER = 0$).

Leaving unused input pins open when the input is enabled may result in misbehavior and possible permanent damage of the device. To prevent latch-up, they must therefore be pulled up or pulled down through resistors which should be more than $2k\Omega$.

Unused bidirectional pins can be set either to the output state and be then left open, or to the input state with either input disabled or external pull-up/pull-down resistor as described above.

13.3 External Clock Usage

The permitted frequency range of an external clock depends on the oscillator type and configuration.

See

AC Characteristics for detailed modes and frequency limits. Single and opposite phase external clocks must be connected as follows:

13.3.1 Single Phase External Clock for Main Oscillator

When using a single phase external clock for the Main oscillator, X0 pin must be driven and X1 pin left open. And supply 1.8V power to the external clock.

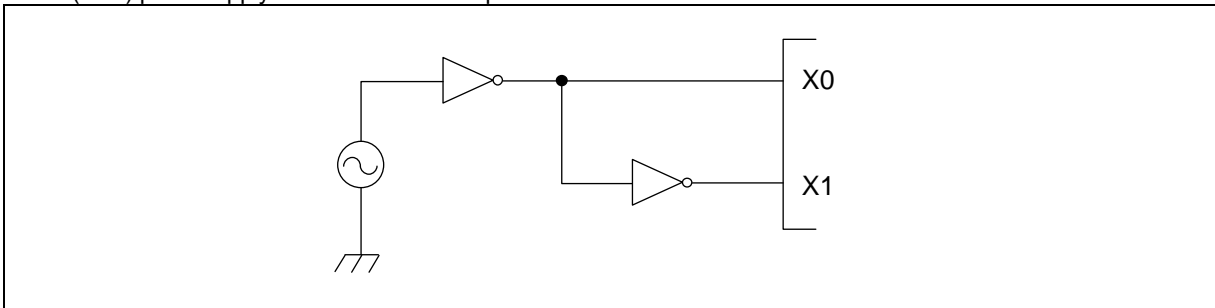


13.3.2 Single Phase External Clock for Sub Oscillator

When using a single phase external clock for the Sub oscillator, "External clock mode" must be selected and X0A/P04_0 pin must be driven. X1A/P04_1 pin can be configured as GPIO.

13.3.3 Opposite Phase External Clock

When using an opposite phase external clock, X1 (X1A) pins must be supplied with a clock signal which has the opposite phase to the X0 (X0A) pins. Supply level on X0 and X1 pins must be 1.8V.



13.4 Notes on PLL Clock Mode Operation

If the microcontroller is operated with PLL clock mode and no external oscillator is operating or no external clock is supplied, the microcontroller attempts to work with the free oscillating PLL. Performance of this operation, however, cannot be guaranteed.

13.5 Power Supply Pins (Vcc/Vss)

It is required that all V_{CC}-level as well as all V_{SS}-level power supply pins are at the same potential. If there is more than one V_{CC} or V_{SS} level, the device may operate incorrectly or be damaged even within the guaranteed operating range.

V_{CC} and V_{SS} pins must be connected to the device from the power supply with lowest possible impedance.

The smoothing capacitor at V_{CC} pin must use the one of a capacity value that is larger than C_s.

Besides this, as a measure against power supply noise, it is required to connect a bypass capacitor of about 0.1μF between V_{CC} and V_{SS} pins as close as possible to V_{CC} and V_{SS} pins.

13.6 Crystal Oscillator and ceramic resonator Circuit

Noise at X0, X1 pins or X0A, X1A pins might cause abnormal operation. It is required to provide bypass capacitors with shortest possible distance to X0, X1 pins and X0A, X1A pins, crystal oscillator (or ceramic resonator) and ground lines, and, to the utmost effort, that the lines of oscillation circuit do not cross the lines of other circuits.

It is highly recommended to provide a printed circuit board art work surrounding X0, X1 pins and X0A, X1A pins with a ground area for stabilizing the operation.

It is highly recommended to evaluate the quartz/MCU or resonator/MCU system at the quartz or resonator manufacturer, especially when using low-Q resonators at higher frequencies.

13.7 Turn on Sequence of Power Supply to A/D Converter and Analog Inputs

It is required to turn the A/D converter power supply (AV_{CC} , $AVRH$) and analog inputs (ANn) on after turning the digital power supply (V_{CC}) on.

It is also required to turn the digital power off after turning the A/D converter supply and analog inputs off. In this case, $AVRH$ must not exceed AV_{CC} . Input voltage for ports shared with analog input ports also must not exceed AV_{CC} (turning the analog and digital power supplies simultaneously on or off is acceptable).

13.8 Pin Handling when Not Using the A/D Converter

If the A/D converter is not used, the power supply pins for A/D converter should be connected such as $AV_{CC} = V_{CC}$, $AV_{SS} = AVRH = V_{SS}$.

13.9 Notes on Power-on

To prevent malfunction of the internal voltage regulator, supply voltage profile while turning the power supply on should be slower than 50 μ s from 0.2V to 2.7V.

13.10 Stabilization of Power Supply Voltage

If the power supply voltage varies acutely even within the operation safety range of the V_{CC} power supply voltage, a malfunction may occur. The V_{CC} power supply voltage must therefore be stabilized. As stabilization guidelines, the power supply voltage must be stabilized in such a way that V_{CC} ripple fluctuations (peak to peak value) in the commercial frequencies (50Hz to 60Hz) fall within 10% of the standard V_{CC} power supply voltage and the transient fluctuation rate becomes 0.1V/ μ s or less in instantaneous fluctuation for power supply switching.

13.11 Serial Communication

There is a possibility to receive wrong data due to noise or other causes on the serial communication.

Therefore, design a printed circuit board so as to avoid noise.

Consider receiving of wrong data when designing the system. For example apply a checksum and retransmit the data if an error occurs.

13.12 Mode Pin (MD)

Connect the mode pin directly to V_{CC} or V_{SS} pin. To prevent the device unintentionally entering test mode due to noise, lay out the printed circuit board so as to minimize the distance from the mode pin to V_{CC} or V_{SS} pin and provide a low-impedance connection.

14. Electrical Characteristics

14.1 Absolute Maximum Ratings

| Parameter | Symbol | Condition | Rating | | Unit | Remarks |
|--|--------------------|----------------------------|----------------|---------------------|------|---|
| | | | Min | Max | | |
| Power supply voltage ^[1] | V_{CC} | - | $V_{SS} - 0.3$ | $V_{SS} + 6.0$ | V | |
| Analog power supply voltage ^[1] | AV_{CC} | - | $V_{SS} - 0.3$ | $V_{SS} + 6.0$ | V | $V_{CC} = AV_{CC}$ ^[2] |
| Analog reference voltage ^[1] | AVRH | - | $V_{SS} - 0.3$ | $V_{SS} + 6.0$ | V | $AV_{CC} \geq AVRH$, $AVRH \geq AV_{SS}$ |
| Input voltage ^[1] | V_I | - | $V_{SS} - 0.3$ | $V_{SS} + 6.0$ | V | $V_I \leq V_{CC} + 0.3V$ ^[3] |
| Output voltage ^[1] | V_O | - | $V_{SS} - 0.3$ | $V_{SS} + 6.0$ | V | $V_O \leq V_{CC} + 0.3V$ ^[3] |
| Maximum Clamp Current | I_{CLAMP} | - | -4.0 | +4.0 | mA | Applicable to general purpose I/O pins ^[4] |
| Total Maximum Clamp Current | $\sum I_{CLAMP} $ | - | - | 13 | mA | Applicable to general purpose I/O pins ^[4] |
| "L" level maximum output current | I_{OL} | - | - | 15 | mA | |
| "L" level average output current | I_{OLAV} | - | - | 4 | mA | |
| "L" level maximum overall output current | $\sum I_{OL}$ | - | - | 32 | mA | |
| "L" level average overall output current | $\sum I_{OLAV}$ | - | - | 16 | mA | |
| "H" level maximum output current | I_{OH} | - | - | -15 | mA | |
| "H" level average output current | I_{OHAV} | - | - | -4 | mA | |
| "H" level maximum overall output current | $\sum I_{OH}$ | - | - | -32 | mA | |
| "H" level average overall output current | $\sum I_{OHAV}$ | - | - | -16 | mA | |
| Power consumption ^[5] | P_D | $T_A = +125^\circ\text{C}$ | - | 284 ^[6] | mW | |
| Operating ambient temperature | T_A | - | -40 | +125 ^[7] | °C | |
| Storage temperature | T_{STG} | - | -55 | +150 | °C | |

[1]: This parameter is based on $V_{SS} = AV_{SS} = 0V$.

[2]: AV_{CC} and V_{CC} must be set to the same voltage. It is required that AV_{CC} does not exceed V_{CC} and that the voltage at the analog inputs does not exceed AV_{CC} when the power is switched on.

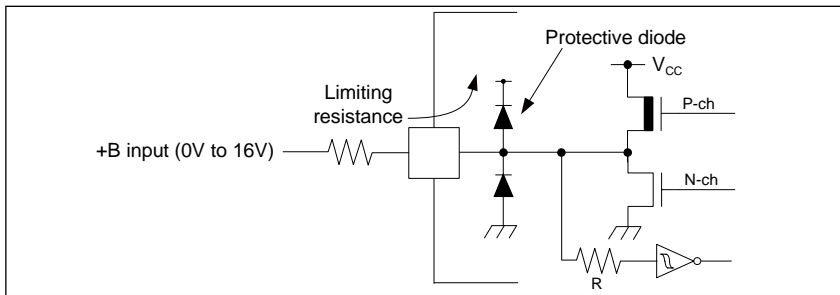
[3]: V_I and V_O should not exceed $V_{CC} + 0.3V$. V_I should also not exceed the specified ratings. However if the maximum current to/from an input is limited by some means with external components, the I_{CLAMP} rating supersedes the V_I rating. Input/Output voltages of standard ports depend on V_{CC} .

[4]:

- Applicable to all general purpose I/O pins (Pnn_m).
- Use within recommended operating conditions.
- Use at DC voltage (current).
- The +B signal should always be applied a limiting resistance placed between the +B signal and the microcontroller.
- The value of the limiting resistance should be set so that when the +B signal is applied the input current to the microcontroller pin does not exceed rated values, either instantaneously or for prolonged periods.

- Note that when the microcontroller drive current is low, such as in the power saving modes, the +B input potential may pass through the protective diode and increase the potential at the VCC pin, and this may affect other devices.
- Note that if a +B signal is input when the microcontroller power supply is off (not fixed at 0V), the power supply is provided from the pins, so that incomplete operation may result.
- Note that if the +B input is applied during power-on, the power supply is provided from the pins and the resulting supply voltage may not be sufficient to operate the Power reset.
- The DEBUG I/F pin has only a protective diode against VSS. Hence it is only permitted to input a negative clamping current (4mA). For protection against positive input voltages, use an external clamping diode which limits the input voltage to maximum 6.0V.

Sample recommended circuits:



[5]: The maximum permitted power dissipation depends on the ambient temperature, the air flow velocity and the thermal conductance of the package on the PCB.

The actual power dissipation depends on the customer application and can be calculated as follows:

$$P_D = P_{IO} + P_{INT}$$

$$P_{IO} = \sum (V_{OL} \times I_{OL} + V_{OH} \times I_{OH}) \text{ (I/O load power dissipation, sum is performed on all I/O ports)}$$

$$P_{INT} = V_{CC} \times (I_{CC} + I_A) \text{ (internal power dissipation)}$$

I_{CC} is the total core current consumption into V_{CC} as described in the "DC characteristics" and depends on the selected operation mode and clock frequency and the usage of functions like Flash programming.

I_A is the analog current consumption into AV_{CC} .

[6]: Worst case value for a package mounted on single layer PCB at specified T_A without air flow.

[7]: Write/erase to a large sector in flash memory is warranted with $T_A \leq +105^\circ\text{C}$.

WARNING:

Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

14.2 Recommended Operating Conditions

($V_{SS} = AV_{SS} = 0V$)

| Parameter | Symbol | Value | | | Unit | Remarks |
|------------------------------|-------------------|-------|------------|-----|---------|---|
| | | Min | Typ | Max | | |
| Power supply voltage | V_{CC}, AV_{CC} | 2.7 | - | 5.5 | V | |
| | | 2.0 | - | 5.5 | V | Maintains RAM data in stop mode |
| Smoothing capacitor at C pin | C_S | 0.5 | 1.0 to 3.9 | 4.7 | μF | 1.0 μF (Allowance within $\pm 50\%$) 3.9 μF (Allowance within $\pm 20\%$) Please use the ceramic capacitor or the capacitor of the frequency response of this level. The smoothing capacitor at V_{CC} must use the one of a capacity value that is larger than C_S . |

WARNING:

The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure. No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

14.3 DC Characteristics

14.3.1 Current Rating

(V_{CC} = AV_{CC} = 2.7V to 5.5V, V_{SS} = AV_{SS} = 0V, T_A = - 40°C to + 125°C)

| Parameter | Symbol | Pin Name | Conditions | Value | | | Unit | Remarks |
|--|---------------------|-----------------|---|-------|------|-----|------|-------------------------|
| | | | | Min | Typ | Max | | |
| Power supply current in Run modes ^[1] | I _{CCPLL} | V _{CC} | PLL Run mode with CLKS1/2 = CLKB = CLKP1/2 = 32MHz Flash 0 wait (CLKRC and CLKSC stopped) | - | 25 | - | mA | T _A = +25°C |
| | | | | - | - | 34 | mA | T _A = +105°C |
| | | | | - | - | 35 | mA | T _A = +125°C |
| | I _{CCMAIN} | | Main Run mode with CLKS1/2 = CLKB = CLKP1/2 = 4MHz Flash 0 wait (CLKPLL, CLKSC and CLKRC stopped) | - | 3.5 | - | mA | T _A = +25°C |
| | | | | - | - | 7.5 | mA | T _A = +105°C |
| | | | | - | - | 8.5 | mA | T _A = +125°C |
| | I _{CCRCH} | | RC Run mode with CLKS1/2 = CLKB = CLKP1/2 = CLKRC = 2MHz Flash 0 wait (CLKMC, CLKPLL and CLKSC stopped) | - | 1.7 | - | mA | T _A = +25°C |
| | | | | - | - | 5.5 | mA | T _A = +105°C |
| | | | | - | - | 6.5 | mA | T _A = +125°C |
| | I _{CCRCL} | | RC Run mode with CLKS1/2 = CLKB = CLKP1/2 = CLKRC = 100kHz Flash 0 wait (CLKMC, CLKPLL and CLKSC stopped) | - | 0.15 | - | mA | T _A = +25°C |
| | | | | - | - | 3.2 | mA | T _A = +105°C |
| | | | | - | - | 4.2 | mA | T _A = +125°C |
| | I _{CCSUB} | | Sub Run mode with CLKS1/2 = CLKB = CLKP1/2 = 32kHz Flash 0 wait (CLKMC, CLKPLL and CLKRC stopped) | - | 0.1 | - | mA | T _A = +25°C |
| | | | | - | - | 3 | mA | T _A = +105°C |
| | | | | - | - | 4 | mA | T _A = +125°C |

| Parameter | Symbol | Pin Name | Conditions | Value | | | Unit | Remarks |
|--|---------------------|-----------------|--|-------|------|-----|------|-------------------------|
| | | | | Min | Typ | Max | | |
| Power supply current in Sleep modes ^[1] | I _{CCSPLL} | V _{CC} | PLL Sleep mode with CLKS1/2 = CLKP1/2 = 32MHz (CLKRC and CLKSC stopped) | - | 6.5 | - | mA | T _A = +25°C |
| | | | | - | - | 13 | mA | T _A = +105°C |
| | | | | - | - | 14 | mA | T _A = +125°C |
| | I _{CCSMAN} | | Main Sleep mode with CLKS1/2 = CLKP1/2 = 4MHz, SMCR:LPMSS = 0 (CLKPLL, CLKRC and CLKSC stopped) | - | 0.9 | - | mA | T _A = +25°C |
| | | | | - | - | 4 | mA | T _A = +105°C |
| | | | | - | - | 5 | mA | T _A = +125°C |
| | I _{CCSRCH} | | RC Sleep mode with CLKS1/2 = CLKP1/2 = CLKRC = 2MHz, SMCR:LPMSS = 0 (CLKMC, CLKPLL and CLKSC stopped) | - | 0.5 | - | mA | T _A = +25°C |
| | | | | - | - | 3.5 | mA | T _A = +105°C |
| | | | | - | - | 4.5 | mA | T _A = +125°C |
| | I _{CCSRCL} | | RC Sleep mode with CLKS1/2 = CLKP1/2 = CLKRC = 100kHz (CLKMC, CLKPLL and CLKSC stopped) | - | 0.06 | - | mA | T _A = +25°C |
| | | | | - | - | 2.7 | mA | T _A = +105°C |
| | | | | - | - | 3.7 | mA | T _A = +125°C |
| | I _{CCSSUB} | | Sub Sleep mode with CLKS1/2 = CLKP1/2 = 32kHz, (CLKMC, CLKPLL and CLKRC stopped) | - | 0.04 | - | mA | T _A = +25°C |
| | | | | - | - | 2.5 | mA | T _A = +105°C |
| | | | | - | - | 3.5 | mA | T _A = +125°C |

| Parameter | Symbol | Pin Name | Conditions | Value | | | Unit | Remarks |
|---|---|-----------------|--|-------|------|-------------------------|-------------------------|-------------------------|
| | | | | Min | Typ | Max | | |
| Power supply current in Timer modes ^[2] | I _{CCTPLL} | V _{CC} | PLL Timer mode with CLKPLL = 32MHz (CLKRC and CLKSC stopped) | - | 1800 | 2245 | μA | T _A = +25°C |
| | | | | - | - | 3165 | μA | T _A = +105°C |
| | | | | - | - | 3975 | μA | T _A = +125°C |
| | I _{CCTMAIN} | | Main Timer mode with CLKMC = 4MHz, SMCR:LPMS = 0 (CLKPLL, CLKRC and CLKSC stopped) | - | 285 | 325 | μA | T _A = +25°C |
| | | | | - | - | 1085 | μA | T _A = +105°C |
| | | | | - | - | 1930 | μA | T _A = +125°C |
| | I _{CCTRCH} | | RC Timer mode with CLKRC = 2MHz, SMCR:LPMS = 0 (CLKPLL, CLKMC and CLKSC stopped) | - | 160 | 210 | μA | T _A = +25°C |
| | | | | - | - | 1025 | μA | T _A = +105°C |
| | | | | - | - | 1840 | μA | T _A = +125°C |
| | I _{CCTRCL} | | RC Timer mode with CLKRC = 100kHz (CLKPLL, CLKMC and CLKSC stopped) | - | 35 | 75 | μA | T _A = +25°C |
| | | | | - | - | 855 | μA | T _A = +105°C |
| | | | | - | - | 1640 | μA | T _A = +125°C |
| I _{CCTSUB} | Sub Timer mode with CLKSC = 32kHz (CLKMC, CLKPLL and CLKRC stopped) | - | 25 | 65 | μA | T _A = +25°C | | |
| | | - | - | 830 | μA | T _A = +105°C | | |
| | | - | - | 1620 | μA | T _A = +125°C | | |
| Power supply current in Stop mode ^[3] | I _{CCH} | - | - | 20 | 55 | μA | T _A = +25°C | |
| | | | - | - | 825 | μA | T _A = +105°C | |
| | | | - | - | 1615 | μA | T _A = +125°C | |
| Flash Power Down current | I _{CCFLASHPD} | - | - | 36 | 70 | μA | | |
| Power supply current for active Low Voltage detector ^[4] | I _{CCCLVD} | V _{CC} | Low voltage detector enabled | - | 5 | - | μA | T _A = +25°C |
| | | | | - | - | 12.5 | μA | T _A = +125°C |
| Flash Write/ Erase current ^[5] | I _{CCFLASH} | - | | - | 12.5 | - | mA | T _A = +25°C |
| | | | | - | - | 20 | mA | T _A = +125°C |

[1]: The power supply current is measured with a 4MHz external clock connected to the Main oscillator and a 32kHz external clock connected to the Sub oscillator. See chapter "Standby mode and voltage regulator control circuit" of the Hardware Manual for further details about voltage regulator control. Current for "On Chip Debugger" part is not included. Power supply current in Run mode does not include Flash Write / Erase current.

[2]: The power supply current in Timer mode is the value when Flash is in Power-down / reset mode.

When Flash is not in Power-down / reset mode, I_{CCFLASHPD} must be added to the Power supply current.

The power supply current is measured with a 4MHz external clock connected to the Main oscillator and a 32kHz external clock connected to the Sub oscillator. The current for "On Chip Debugger" part is not included.

[3]: The power supply current in Stop mode is the value when Flash is in Power-down / reset mode.

When Flash is not in Power-down / reset mode, I_{CCFLASHPD} must be added to the Power supply current.

[4]: When low voltage detector is enabled, I_{CCCLVD} must be added to Power supply current.

[5]: When Flash Write / Erase program is executed, I_{CCFLASH} must be added to Power supply current.

14.3.2 Pin Characteristics
 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } +125^{\circ}C)$

| Parameter | Symbol | Pin Name | Conditions | Value | | | Unit | Remarks |
|--------------------------|--------------|--|--|---------------------|-----|---------------------|------|-----------------------------|
| | | | | Min | Typ | Max | | |
| "H" level input voltage | V_{IH} | Port inputs Pnn_m | - | $V_{CC} \times 0.7$ | - | $V_{CC} + 0.3$ | V | CMOS Hysteresis input |
| | | | - | $V_{CC} \times 0.8$ | - | $V_{CC} + 0.3$ | V | AUTOMOTIVE Hysteresis input |
| | V_{IHx0S} | X0 | External clock in "Fast Clock Input mode" | $VD \times 0.8$ | - | VD | V | VD=1.8V±0.15V |
| | V_{IHx0AS} | X0A | External clock in "Oscillation mode" | $V_{CC} \times 0.8$ | - | $V_{CC} + 0.3$ | V | |
| | V_{IHR} | RSTX | - | $V_{CC} \times 0.8$ | - | $V_{CC} + 0.3$ | V | CMOS Hysteresis input |
| | V_{IHM} | MD | - | $V_{CC} - 0.3$ | - | $V_{CC} + 0.3$ | V | CMOS Hysteresis input |
| "L" level input voltage | V_{IL} | Port inputs Pnn_m | - | $V_{SS} - 0.3$ | - | $V_{CC} \times 0.3$ | V | CMOS Hysteresis input |
| | | | - | $V_{SS} - 0.3$ | - | $V_{CC} \times 0.5$ | V | AUTOMOTIVE Hysteresis input |
| | V_{ILx0S} | X0 | External clock in "Fast Clock Input mode" | V_{SS} | - | $VD \times 0.2$ | V | VD=1.8V±0.15V |
| | V_{ILx0AS} | X0A | External clock in "Oscillation mode" | $V_{SS} - 0.3$ | - | $V_{CC} \times 0.2$ | V | |
| | V_{ILR} | RSTX | - | $V_{SS} - 0.3$ | - | $V_{CC} \times 0.2$ | V | CMOS Hysteresis input |
| | V_{ILM} | MD | - | $V_{SS} - 0.3$ | - | $V_{SS} + 0.3$ | V | CMOS Hysteresis input |
| "H" level output voltage | V_{OH4} | 4mA type | $4.5V \leq V_{CC} \leq 5.5V$ $I_{OH} = -4mA$ | $V_{CC} - 0.5$ | - | V_{CC} | V | |
| | | | $2.7V \leq V_{CC} < 4.5V$ $I_{OH} = -1.5mA$ | | | | | |
| "L" level output voltage | V_{OL4} | 4mA type | $4.5V \leq V_{CC} \leq 5.5V$ $I_{OL} = +4mA$ | - | - | 0.4 | V | |
| | | | $2.7V \leq V_{CC} < 4.5V$ $I_{OL} = +1.7mA$ | | | | | |
| | V_{OLD} | DEBUG I/F | $V_{CC} = 2.7V$ $I_{OL} = +25mA$ | 0 | - | 0.25 | V | |
| Input leak current | I_{IL} | Pnn_m | $V_{SS} < V_I < V_{CC}$ $AV_{SS} < V_I < AV_{CC}$, AVRH | -1 | - | +1 | µA | |
| Pull-up resistance value | R_{PU} | Pnn_m | $V_{CC} = 5.0V \pm 10\%$ | 25 | 50 | 100 | kΩ | |
| Input capacitance | C_{IN} | Other than C, Vcc, Vss, AVcc, AVss, AVRH | - | - | 5 | 15 | pF | |

14.4 AC Characteristics

14.4.1 Main Clock Input Characteristics

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_D = 1.8V \pm 0.15V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^\circ C$ to $+125^\circ C$)

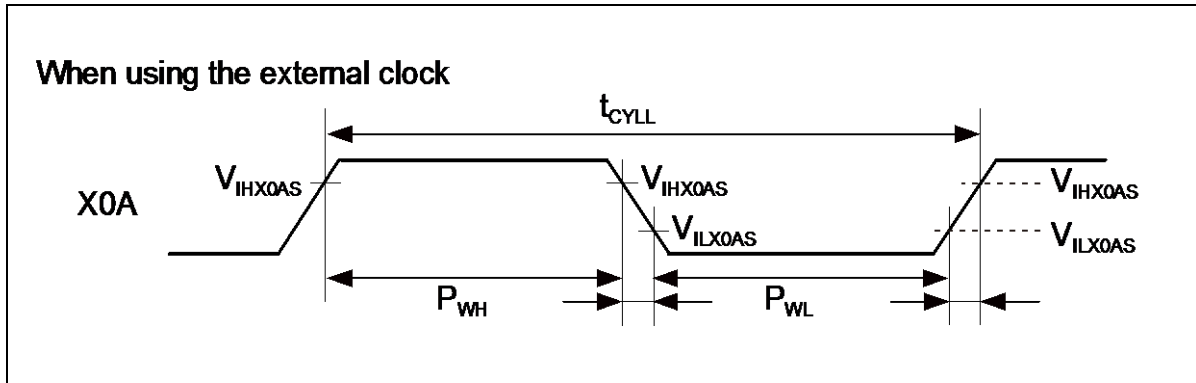
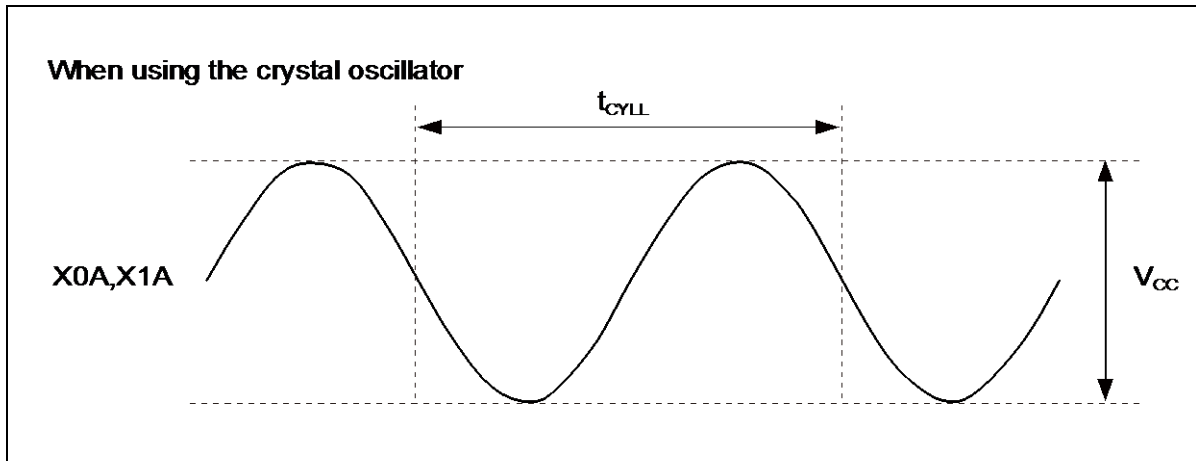
| Parameter | Symbol | Pin Name | Value | | | Unit | Remarks |
|-------------------------|------------------|----------|-------|-----|-----|------|--|
| | | | Min | Typ | Max | | |
| Input frequency | f_C | X0, X1 | 4 | - | 8 | MHz | When using a crystal oscillator, PLL off |
| | | | - | - | 8 | MHz | When using an opposite phase external clock, PLL off |
| | | | 4 | - | 8 | MHz | When using a crystal oscillator or opposite phase external clock, PLL on |
| Input frequency | f_{FCI} | X0 | - | - | 8 | MHz | When using a single phase external clock in "Fast Clock Input mode", PLL off |
| | | | 4 | - | 8 | MHz | When using a single phase external clock in "Fast Clock Input mode", PLL on |
| Input clock cycle | t_{CYLH} | - | 125 | - | - | ns | |
| Input clock pulse width | P_{WH}, P_{WL} | - | 55 | - | - | ns | |



14.4.2 Sub Clock Input Characteristics

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Pin Name | Conditions | Value | | | Unit | Remarks |
|-------------------------|------------|----------|--|-------|--------|-----|---------|---|
| | | | | Min | Typ | Max | | |
| Input frequency | f_{CL} | X0A, X1A | - | - | 32.768 | - | kHz | When using an oscillation circuit |
| | | | - | - | - | 100 | kHz | When using an opposite phase external clock |
| | | X0A | - | - | - | 50 | kHz | When using a single phase external clock |
| Input clock cycle | t_{CYLL} | - | - | 10 | - | - | μs | |
| Input clock pulse width | - | - | P_{WH}/t_{CYLL} , P_{WL}/t_{CYLL} | 30 | - | 70 | % | |



14.4.3 Built-in RC Oscillation Characteristics

 ($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Value | | | Unit | Remarks |
|-----------------------------|--------------|-------|-----|-----|---------|---|
| | | Min | Typ | Max | | |
| Clock frequency | f_{RC} | 50 | 100 | 200 | kHz | When using slow frequency of RC oscillator |
| | | 1 | 2 | 4 | | MHz |
| RC clock stabilization time | t_{RCSTAB} | 80 | 160 | 320 | μs | When using slow frequency of RC oscillator (16 RC clock cycles) |
| | | 64 | 128 | 256 | | μs |

14.4.4 Internal Clock Timing

 ($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Value | | Unit |
|--|------------------------|-------|-----|------|
| | | Min | Max | |
| Internal System clock frequency (CLKS1 and CLKS2) | f_{CLKS1}, f_{CLKS2} | - | 54 | MHz |
| Internal CPU clock frequency (CLKB), Internal peripheral clock frequency (CLKP1) | f_{CLKB}, f_{CLKP1} | - | 32 | MHz |
| Internal peripheral clock frequency (CLKP2) | f_{CLKP2} | - | 32 | MHz |

14.4.5 Operating Conditions of PLL

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Value | | | Unit | Remarks |
|---|--------------|-------|-----|-----|------|--|
| | | Min | Typ | Max | | |
| PLL oscillation stabilization wait time | t_{LOCK} | 1 | - | 4 | ms | For CLKMC = 4MHz |
| PLL input clock frequency | f_{PLLI} | 4 | - | 8 | MHz | |
| PLL oscillation clock frequency | f_{CLKVCO} | 56 | - | 108 | MHz | Permitted VCO output frequency of PLL (CLKVCO) |
| PLL phase jitter | t_{PSKEW} | -5 | - | +5 | ns | For CLKMC (PLL input clock) $\geq 4MHz$ |



14.4.6 Reset Input

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Pin Name | Value | | Unit |
|-------------------------------|------------|----------|-------|-----|---------|
| | | | Min | Max | |
| Reset input time | t_{RSTL} | RSTX | 10 | - | μs |
| Rejection of reset input time | | | 1 | - | μs |



14.4.7 Power-on Reset Timing

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Pin Name | Value | | | Unit |
|--------------------|-----------|----------|-------|-----|-----|------|
| | | | Min | Typ | Max | |
| Power on rise time | t_R | V_{CC} | 0.05 | - | 30 | ms |
| Power off time | t_{OFF} | V_{CC} | 1 | - | - | ms |



14.4.8 USART Timing
 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } +125^{\circ}C, C_L=50pF)$

| Parameter | Symbol | Pin name | Conditions | 4.5V ≤ V _{CC} < 5.5V | | 2.7V ≤ V _{CC} < 4.5V | | Unit |
|------------------------------|--------------------|------------|---------------------------|-------------------------------|--------------------------|-------------------------------|--------------------------|------|
| | | | | Min | Max | Min | Max | |
| Serial clock cycle time | t _{SCYC} | SCKn | Internal shift clock mode | 4t _{CLKP1} | - | 4t _{CLKP1} | - | ns |
| SCK ↓ → SOT delay time | t _{SLOVI} | SCKn, SOTn | | - 20 | + 20 | - 30 | + 30 | ns |
| SOT → SCK ↑ delay time | t _{OVSHI} | SCKn, SOTn | | Nxt _{CLKP1} - 20* | - | Nxt _{CLKP1} - 30* | - | ns |
| SIN → SCK ↑ setup time | t _{IVSHI} | SCKn, SINn | | t _{CLKP1} + 45 | - | t _{CLKP1} + 55 | - | ns |
| SCK ↑ → SIN hold time | t _{SHIXI} | SCKn, SINn | | 0 | - | 0 | - | ns |
| Serial clock "L" pulse width | t _{SLSH} | SCKn | External shift clock mode | t _{CLKP1} + 10 | - | t _{CLKP1} + 10 | - | ns |
| Serial clock "H" pulse width | t _{SHSL} | SCKn | | t _{CLKP1} + 10 | - | t _{CLKP1} + 10 | - | ns |
| SCK ↓ → SOT delay time | t _{SLOVE} | SCKn, SOTn | | - | 2t _{CLKP1} + 45 | - | 2t _{CLKP1} + 55 | ns |
| SIN → SCK ↑ setup time | t _{IVSHE} | SCKn, SINn | | t _{CLKP1} /2 + 10 | - | t _{CLKP1} /2 + 10 | - | ns |
| SCK ↑ → SIN hold time | t _{SHIXE} | SCKn, SINn | | t _{CLKP1} + 10 | - | t _{CLKP1} + 10 | - | ns |
| SCK fall time | t _F | SCKn | | - | 20 | - | 20 | ns |
| SCK rise time | t _R | SCKn | | - | 20 | - | 20 | ns |

Notes:

- AC characteristic in CLK synchronized mode
- C_L is the load capacity value of pins when testing.
- Depending on the used machine clock frequency, the maximum possible baud rate can be limited by some parameters. These parameters are shown in "CY96600 series HARDWARE MANUAL".
- t_{CLKP1} indicates the peripheral clock 1 (CLKP1), Unit: ns
These characteristics only guarantee the same relocate port number.

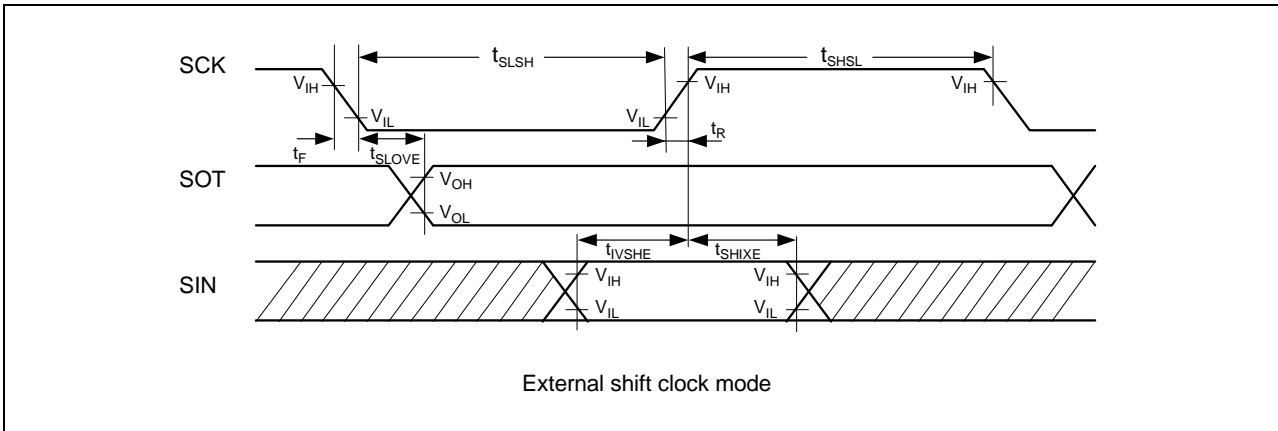
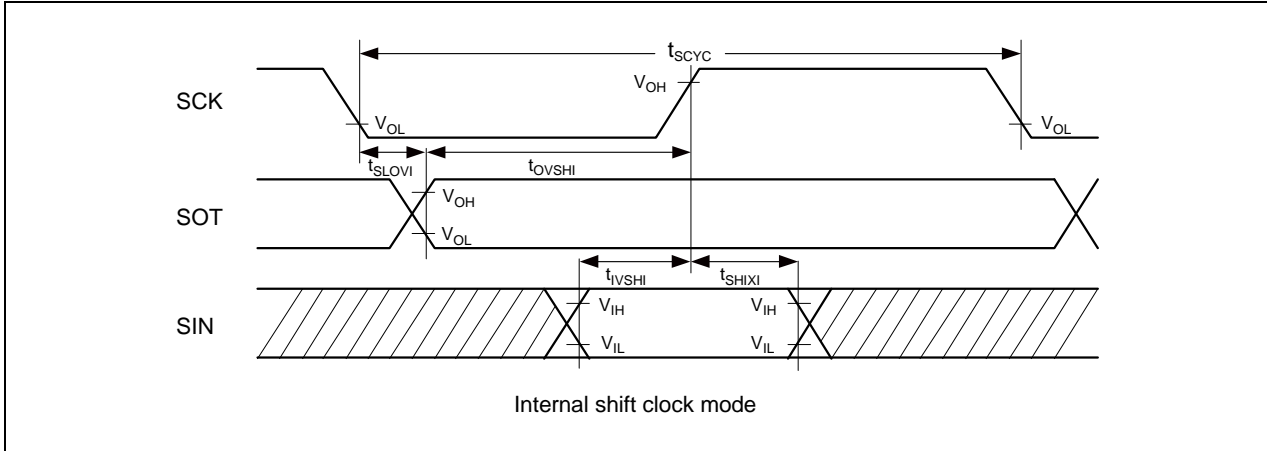
For example, the combination of SCKn and SOTn_R is not guaranteed.

*: Parameter N depends on t_{SCYC} and can be calculated as follows:

- If t_{SCYC} = 2 × k × t_{CLKP1}, then N = k, where k is an integer > 2
- If t_{SCYC} = (2 × k + 1) × t_{CLKP1}, then N = k + 1, where k is an integer > 1

Examples:

| | |
|---|---|
| t _{SCYC} | N |
| 4 × t _{CLKP1} | 2 |
| 5 × t _{CLKP1} , 6 × t _{CLKP1} | 3 |
| 7 × t _{CLKP1} , 8 × t _{CLKP1} | 4 |



14.4.9 External Input Timing

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Pin Name | Value | | Unit | Remarks |
|-------------------|--------------------|-----------------------|---|-----|------|--|
| | | | Min | Max | | |
| Input pulse width | t_{INH}, t_{INL} | Pnn_m | $2t_{CLKP1} + 200$ $(t_{CLKP1}=1/f_{CLKP1})^*$ | - | ns | General Purpose I/O |
| | | ADTG_R | | | | A/D Converter trigger input |
| | | TINn | | | | Reload Timer |
| | | TTGn | | | | PPG trigger input |
| | | INn | | | | Input Capture |
| | | AINn, BINn, ZINn | | | | Quadrature Position/Revolution Counter |
| | | INTn, INTn_R, INTn_R1 | 200 | - | ns | External Interrupt |
| | | NMI | | | | Non-Maskable Interrupt |

*: t_{CLKP1} indicates the peripheral clock1 (CLKP1) cycle time except stop when in stop mode.



14.5 A/D Converter
14.5.1 Electrical Characteristics for the A/D Converter
 $(V_{CC} = AV_{CC} = 2.7V \text{ to } 5.5V, V_{SS} = AV_{SS} = 0V, T_A = -40^{\circ}C \text{ to } +125^{\circ}C)$

| Parameter | Symbol | Pin Name | Value | | | Unit | Remarks |
|---|-----------|-----------|-----------------|--------------------|-----------|----------|-------------------------------------|
| | | | Min | Typ | Max | | |
| Resolution | - | - | - | - | 10 | bit | |
| Total error | - | - | - 3.0 | - | + 3.0 | LSB | |
| Nonlinearity error | - | - | - 2.5 | - | + 2.5 | LSB | |
| Differential Nonlinearity error | - | - | - 1.9 | - | + 1.9 | LSB | |
| Zero transition voltage | V_{OT} | ANn | Typ - 20 | $AV_{SS} + 0.5LSB$ | Typ + 20 | mV | |
| Full scale transition voltage | V_{FST} | ANn | Typ - 20 | $AVRH - 1.5LSB$ | Typ + 20 | mV | |
| Compare time* | - | - | 1.0 | - | 5.0 | μs | $4.5V \leq AV_{CC} \leq 5.5V$ |
| | | | 2.2 | - | 8.0 | μs | $2.7V \leq AV_{CC} < 4.5V$ |
| Sampling time* | - | - | 0.5 | - | - | μs | $4.5V \leq AV_{CC} \leq 5.5V$ |
| | | | 1.2 | - | - | μs | $2.7V \leq AV_{CC} < 4.5V$ |
| Power supply current | I_A | AV_{CC} | - | 2.0 | 3.1 | mA | A/D Converter active |
| | I_{AH} | | - | - | 3.3 | μA | A/D Converter not operated |
| Reference power supply current (between AVRH and AV_{SS}) | I_R | AVRH | - | 520 | 810 | μA | A/D Converter active |
| | I_{RH} | | - | - | 1.0 | μA | A/D Converter not operated |
| Analog input capacity | C_{VIN} | ANn | - | - | 15.6 | pF | |
| Analog impedance | R_{VIN} | ANn | - | - | 2050 | Ω | $4.5V \leq AV_{CC} \leq 5.5V$ |
| | | | - | - | 3600 | Ω | $2.7V \leq AV_{CC} < 4.5V$ |
| Analog port input current (during conversion) | I_{AIN} | ANn | - 0.3 | - | + 0.3 | Ω | $AV_{SS} < V_{AIN} < AV_{CC}, AVRH$ |
| Analog input voltage | V_{AIN} | ANn | AV_{SS} | - | AVRH | V | |
| Reference voltage range | - | AVRH | $AV_{CC} - 0.1$ | - | AV_{CC} | V | |
| Variation between channels | - | ANn | - | - | 4.0 | LSB | |

*: Time for each channel.

14.5.2 Accuracy and Setting of the A/D Converter Sampling Time

If the external impedance is too high or the sampling time too short, the analog voltage charged to the internal sample and hold capacitor is insufficient, adversely affecting the A/D conversion precision.

To satisfy the A/D conversion precision, a sufficient sampling time must be selected. The required sampling time (T_{samp}) depends on the external driving impedance R_{ext} , the board capacitance of the A/D converter input pin C_{ext} and the AV_{CC} voltage level. The following replacement model can be used for the calculation:



R_{ext} : External driving impedance

C_{ext} : Capacitance of PCB at A/D converter input

C_{VIN} : Analog input capacity (I/O, analog switch and ADC are contained)

R_{VIN} : Analog input impedance (I/O, analog switch and ADC are contained)

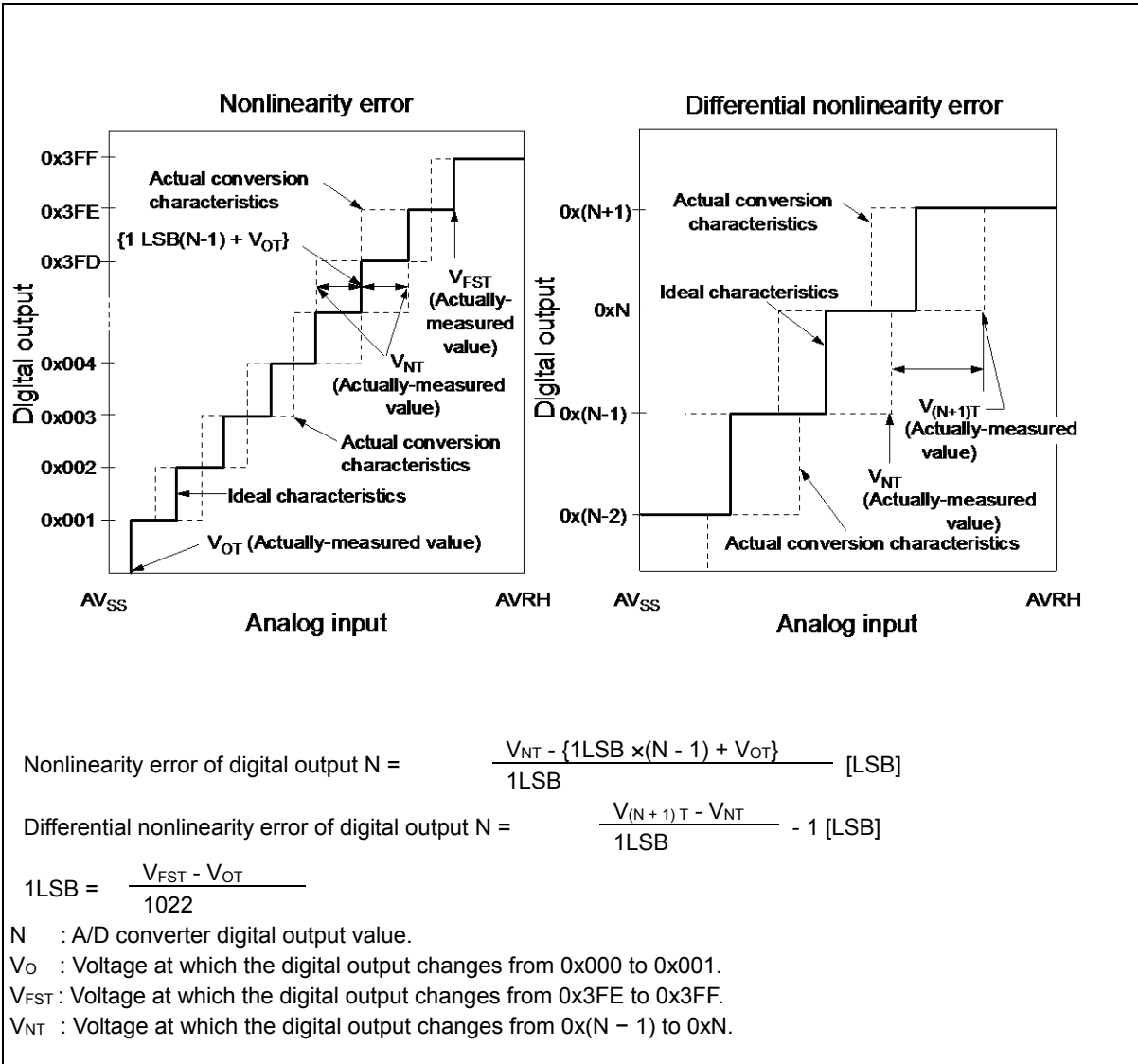
The following approximation formula for the replacement model above can be used:

$$T_{\text{samp}} = 7.62 \times (R_{\text{ext}} \times C_{\text{ext}} + (R_{\text{ext}} + R_{\text{VIN}}) \times C_{\text{VIN}})$$

- Do not select a sampling time below the absolute minimum permitted value.
($0.5\mu\text{s}$ for $4.5\text{V} \leq AV_{\text{CC}} \leq 5.5\text{V}$, $1.2\mu\text{s}$ for $2.7\text{V} \leq AV_{\text{CC}} < 4.5\text{V}$)
- If the sampling time cannot be sufficient, connect a capacitor of about $0.1\mu\text{F}$ to the analog input pin.
- A big external driving impedance also adversely affects the A/D conversion precision due to the pin input leakage current I_{IL} (static current before the sampling switch) or the analog input leakage current I_{AIN} (total leakage current of pin input and comparator during sampling). The effect of the pin input leakage current I_{IL} cannot be compensated by an external capacitor.
- The accuracy gets worse as $|AV_{\text{RH}} - AV_{\text{SS}}|$ becomes smaller.

14.5.3 Definition of A/D Converter Terms

- Resolution : Analog variation that is recognized by an A/D converter.
- Nonlinearity error : Deviation of the actual conversion characteristics from a straight line that connects the zero transition point ($0b0000000000 \longleftrightarrow 0b0000000001$) to the full-scale transition point ($0b1111111110 \longleftrightarrow 0b1111111111$).
- Differential nonlinearity error : Deviation from the ideal value of the input voltage that is required to change the output code by 1LSB.
- Total error : Difference between the actual value and the theoretical value. The total error includes zero transition error, full-scale transition error and nonlinearity error.
- Zero transition voltage: Input voltage which results in the minimum conversion value.
- Full scale transition voltage: Input voltage which results in the maximum conversion value.





$$1\text{LSB (Ideal value)} = \frac{\text{AVRH} - \text{AVSS}}{1024} \text{ [V]}$$

$$\text{Total error of digital output N} = \frac{V_{\text{NT}} - \{1\text{LSB} \times (N - 1) + 0.5\text{LSB}\}}{1\text{LSB}}$$

N : A/D converter digital output value.

V_{NT} : Voltage at which the digital output changes from 0x(N + 1) to 0xN.

V_{OT} (Ideal value) = AVSS + 0.5LSB[V]

V_{FST} (Ideal value) = AVRH - 1.5LSB[V]

14.6 Low Voltage Detection Function Characteristics

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | Symbol | Conditions | Value | | | Unit |
|---|---------------|-------------------------------|---------|------|---------|------------|
| | | | Min | Typ | Max | |
| Detected voltage ^[1] | V_{DL0} | CILCR:LVL = 0000 _B | 2.70 | 2.90 | 3.10 | V |
| | V_{DL1} | CILCR:LVL = 0001 _B | 2.79 | 3.00 | 3.21 | V |
| | V_{DL2} | CILCR:LVL = 0010 _B | 2.98 | 3.20 | 3.42 | V |
| | V_{DL3} | CILCR:LVL = 0011 _B | 3.26 | 3.50 | 3.74 | V |
| | V_{DL4} | CILCR:LVL = 0100 _B | 3.45 | 3.70 | 3.95 | V |
| | V_{DL5} | CILCR:LVL = 0111 _B | 3.73 | 4.00 | 4.27 | V |
| | V_{DL6} | CILCR:LVL = 1001 _B | 3.91 | 4.20 | 4.49 | V |
| Power supply voltage change rate ^[2] | dV/dt | - | - 0.004 | - | + 0.004 | V/ μ s |
| Hysteresis width | V_{HYS} | CILCR:L VHYS=0 | - | - | 50 | mV |
| | | CILCR:L VHYS=1 | 80 | 100 | 120 | mV |
| Stabilization time | $T_{LVDSTAB}$ | - | - | - | 75 | μ s |
| Detection delay time | t_d | - | - | - | 30 | μ s |

[1]: If the power supply voltage fluctuates within the time less than the detection delay time (t_d), there is a possibility that the low voltage detection will occur or stop after the power supply voltage passes the detection range.

[2]: In order to perform the low voltage detection at the detection voltage (V_{DLX}), be sure to suppress fluctuation of the power supply voltage within the limits of the change ration of power supply voltage.





14.7 Flash Memory Write/Erase Characteristics

 ($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

| Parameter | | Conditions | Value | | | Unit | Remarks |
|--------------------------|-----------------|--------------------------|-------|------|-------|---------|--|
| | | | Min | Typ | Max | | |
| Sector erase time | Large Sector | $T_A \leq +105^{\circ}C$ | - | 1.6 | 7.5 | s | Includes write time prior to internal erase. |
| | Small Sector | - | - | 0.4 | 2.1 | s | |
| | Security Sector | - | - | 0.31 | 1.65 | s | |
| Word (16-bit) write time | Large Sector | $T_A \leq +105^{\circ}C$ | - | 25 | 400 | μs | Not including system-level overhead time. |
| | Small Sector | - | - | 25 | 400 | μs | |
| Chip erase time | | $T_A \leq +105^{\circ}C$ | - | 5.11 | 25.05 | s | Includes write time prior to internal erase. |

Note:

While the Flash memory is written or erased, shutdown of the external power (V_{CC}) is prohibited. In the application system where the external power (V_{CC}) might be shut down while writing or erasing, be sure to turn the power off by using a low voltage detection function.

To put it concrete, change the external power in the range of change ration of power supply voltage ($-0.004V/\mu s$ to $+0.004V/\mu s$) after the external power falls below the detection voltage (V_{DLX})¹.

Write/Erase cycles and data hold time

| Write/Erase Cycles (Cycle) | Data Hold Time (Year) |
|----------------------------|-----------------------|
| 1,000 | 20 ^[2] |
| 10,000 | 10 ^[2] |
| 100,000 | 5 ^[2] |

[1]: See "14.6 Low Voltage Detection Function Characteristics".

[2]: This value comes from the technology qualification (using Arrhenius equation to translate high temperature measurements into normalized value at $+85^{\circ}C$).

15. Example Characteristics

This characteristic is an actual value of the arbitrary sample. It is not the guaranteed value.

CY96F615



CY96F615



Used Setting

| Mode | Selected Source Clock | Clock/Regulator and FLASH Settings |
|------------|-----------------------|---|
| Run mode | PLL | CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 32MHz |
| | Main osc. | CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 4MHz |
| | RC clock fast | CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 2MHz |
| | RC clock slow | CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 100kHz |
| | Sub osc. | CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 32kHz |
| Sleep mode | PLL | CLKS1 = CLKS2 = CLKP1 = CLKP2 = 32MHz Regulator in High Power Mode, (CLKB is stopped in this mode) |
| | Main osc. | CLKS1 = CLKS2 = CLKP1 = CLKP2 = 4MHz Regulator in High Power Mode, (CLKB is stopped in this mode) |
| | RC clock fast | CLKS1 = CLKS2 = CLKP1 = CLKP2 = 2MHz Regulator in High Power Mode, (CLKB is stopped in this mode) |
| | RC clock slow | CLKS1 = CLKS2 = CLKP1 = CLKP2 = 100kHz Regulator in Low Power Mode, (CLKB is stopped in this mode) |
| | Sub osc. | CLKS1 = CLKS2 = CLKP1 = CLKP2 = 32kHz Regulator in Low Power Mode, (CLKB is stopped in this mode) |
| Timer mode | PLL | CLKMC = 4MHz, CLKPLL = 32MHz (System clocks are stopped in this mode) Regulator in High Power Mode, FLASH in Power-down / reset mode |
| | Main osc. | CLKMC = 4MHz (System clocks are stopped in this mode) Regulator in High Power Mode, FLASH in Power-down / reset mode |
| | RC clock fast | CLKMC = 2MHz (System clocks are stopped in this mode) Regulator in High Power Mode, FLASH in Power-down / reset mode |
| | RC clock slow | CLKMC = 100kHz (System clocks are stopped in this mode) Regulator in Low Power Mode, FLASH in Power-down / reset mode |
| | Sub osc. | CLKMC = 32 kHz (System clocks are stopped in this mode) Regulator in Low Power Mode, FLASH in Power-down / reset mode |
| Stop mode | stopped | (All clocks are stopped in this mode) Regulator in Low Power Mode, FLASH in Power-down / reset mode |

16. Ordering Information

MCU with CAN Controller

| Part Number | Flash Memory | Package* |
|-------------------------|-------------------|------------------------------|
| CY96F612RBPMC-GS-UJE1 | Flash A (64.5KB) | 48-pin plastic LQFP (LQA048) |
| CY96F612RBPMC-GS-UJE2 | | |
| CY96F613RBPMC-GS-UJE1 | Flash A (96.5KB) | 48-pin plastic LQFP (LQA048) |
| CY96F613RBPMC-GS-UJE2 | | |
| CY96F613RBPMC-GS-UJERE2 | | |
| CY96F615RBPMC-GS-UJE1 | Flash A (160.5KB) | 48-pin plastic LQFP (LQA048) |
| CY96F615RBPMC-GS-UJE2 | | |
| CY96F615RBPMC-GS-UJERE2 | | |

*: For details about package, see "[Package Dimension](#)".

MCU without CAN Controller

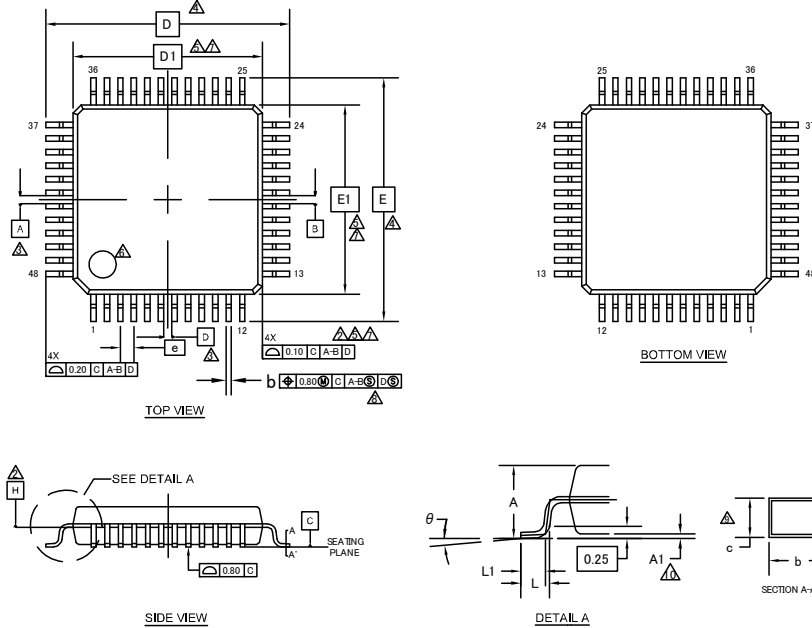
| Part Number | Flash Memory | Package* |
|-----------------------|-------------------|------------------------------|
| CY96F612ABPMC-GS-UJE1 | Flash A (64.5KB) | 48-pin plastic LQFP (LQA048) |
| CY96F612ABPMC-GS-UJE2 | | |
| CY96F613ABPMC-GS-UJE1 | Flash A (96.5KB) | 48-pin plastic LQFP (LQA048) |
| CY96F613ABPMC-GS-UJE2 | | |
| CY96F615ABPMC-GS-UJE1 | Flash A (160.5KB) | 48-pin plastic LQFP (LQA048) |

*: For details about package, see "[Package Dimension](#)".

17. Package Dimension

LQA048, 48 Lead Plastic Low Profile Quad Flat Package

| Package Type | Package Code |
|--------------|--------------|
| LQFP 48pin | LQA048 |



| SYMBOL | DIMENSIONS | | |
|--------|------------|------|------|
| | MIN. | NOM. | MAX. |
| A | — | — | 1.70 |
| A1 | 0.00 | — | 0.20 |
| b | 0.15 | — | 0.27 |
| c | 0.09 | — | 0.20 |
| D | 9.00 BSC | | |
| D1 | 7.00 BSC | | |
| e | 0.50 BSC | | |
| E | 9.00 BSC | | |
| E1 | 7.00 BSC | | |
| L | 0.45 | 0.60 | 0.75 |
| L1 | 0.30 | 0.50 | 0.70 |
| θ | 0° | — | 8° |

NOTES

- ALL DIMENSIONS ARE IN MILLIMETERS.
- DATUM PLANE H IS LOCATED AT THE BOTTOM OF THE MOLD PARTING LINE COINCIDENT WITH WHERE THE LEAD EXITS THE BODY.
- DATUMS A-B AND D TO BE DETERMINED AT DATUM PLANE H.
- TO BE DETERMINED AT SEATING PLANE C.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25mm PRE SIDE. DIMENSIONS D1 AND E1 INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
- DETAILS OF PIN 1 IDENTIFIER ARE OPTIONAL BUT MUST BE LOCATED WITHIN THE ZONE INDICATED.
- REGARDLESS OF THE RELATIVE SIZE OF THE UPPER AND LOWER BODY SECTIONS. DIMENSIONS D1 AND E1 ARE DETERMINED AT THE LARGEST FEATURE OF THE BODY EXCLUSIVE OF MOLD FLASH AND GATE BURRS. BUT INCLUDING ANY MISMATCH BETWEEN THE UPPER AND LOWER SECTIONS OF THE MOLDER BODY.
- DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. THE DAMBAR PROTRUSION (S) SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED b MAXIMUM BY MORE THAN 0.08mm. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE LEAD FOOT.
- THESE DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.10mm AND 0.25mm FROM THE LEAD TIP.
- A1 IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.

002-13731 **

PACKAGE OUTLINE, 48 LEAD LQFP
7.0X7.0X1.7 MM LQA048 REV**

18. Major Changes

Spancion Publication Number: MB96610_DS704-00007

| Page | Section | Change Results |
|--------------|--|--|
| Revision 3.0 | | |
| 4 | ■FEATURES | Changed the description of "External Interrupts" Interrupt mask and pending bit per channel Interrupt mask bit per channel |
| 23 to 26 | ■HANDLING PRECAUTIONS | Added a section |
| 34 | ■ELECTRICAL CHARACTERISTICS 3. DC Characteristics (1) Current Rating | Changed the Conditions for I_{CCSRCH} CLKS1/2 = CLKB = CLKP1/2 = CLKRC = 2MHz, CLKS1/2 = CLKP1/2 = CLKRC = 2MHz, |
| | | Changed the Conditions for I_{CCSRCL} CLKS1/2 = CLKB = CLKP1/2 = CLKRC = 100kHz CLKS1/2 = CLKP1/2 = CLKRC = 100kHz |
| 35 | | Changed the Conditions for I_{CCTPLL} PLL Timer mode with CLKP1 = 32MHz PLL Timer mode with CLKPLL = 32MHz |
| | | Changed the Value of "Power supply current in Timer modes" I_{CCTPLL} Typ: 2480 μ A → 1800 μ A ($T_A = +25^{\circ}$ C) Max: 2710 μ A → 2245 μ A ($T_A = +25^{\circ}$ C) Max: 3985 μ A → 3165 μ A ($T_A = +105^{\circ}$ C) Max: 4830 μ A → 3975 μ A ($T_A = +125^{\circ}$ C) |
| | | Changed the Conditions for I_{CCTRCL} RC Timer mode with CLKRC = 100kHz, SMCR:LPMSS = 0 (CLKPLL, CLKMC and CLKSC stopped) RC Timer mode with CLKRC = 100kHz (CLKPLL, CLKMC and CLKSC stopped) |
| 36 | | Changed the annotation *2 Power supply for "On Chip Debugger" part is not included. Power supply current in Run mode does not include Flash Write / Erase current. The current for "On Chip Debugger" part is not included. |
| 47 | 5. A/D Converter (2) Accuracy and Setting of the A/D Converter Sampling Time | Deleted the unit "[Min]" from approximation formula of Sampling time |
| 52 | 7. Flash Memory Write/Erase Characteristics | Changed the condition ($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_D = 1.8V \pm 0.15V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}$ C to $+125^{\circ}$ C) ($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}$ C to $+125^{\circ}$ C) |

| Page | Section | Change Results |
|--------------|---|---|
| 52 | ■ELECTRICAL CHARACTERISTICS 7. Flash Memory Write/Erase Characteristics | Changed the Note While the Flash memory is written or erased, shutdown of the external power (V_{CC}) is prohibited. In the application system where the external power (V_{CC}) might be shut down while writing, be sure to turn the power off by using an external voltage detector. While the Flash memory is written or erased, shutdown of the external power (V_{CC}) is prohibited. In the application system where the external power (V_{CC}) might be shut down while writing or erasing, be sure to turn the power off by using a low voltage detection function. |
| 56 | ■ORDERING INFORMATION | Deleted the Part number MCU with CAN controller MB96F612RBPMC-GTE2 MB96F613RBPMC-GTE2 MB96F615RBPMC-GTE2 MCU without CAN controller MB96F612ABPMC-GTE2 MB96F613ABPMC-GTE2 MB96F615ABPMC-GTE2 |
| Revision 3.1 | | |
| - | - | Company name and layout design change |
| Rev.*B | | |
| 6, 8, 58, 59 | 1. Product Lineup 3. Pin Assignment 16. Ordering Information 17. Package Dimension | Package description modified to JEDEC description. FPT-48P-M26 → LQA048 |
| 58 | 16. Ordering Information | Added the following part number. MB96F612RBPMC-GS-UJE1, MB96F612RBPMC-GS-UJE2, MB96F613RBPMC-GS-UJE1, MB96F613RBPMC-GS-UJE2, MB96F615RBPMC-GS-UJE1, MB96F615RBPMC-GS-UJE2, MB96F612ABPMC-GS-UJE1, MB96F612ABPMC-GS-UJE2, MB96F613ABPMC-GS-UJE1, MB96F613ABPMC-GS-UJE2, MB96F615ABPMC-GS-UJE1, MB96F615ABPMC-GS-UJE2 |
| Rev.*C | | |
| 58 | 16. Ordering Information | Deleted the Part number MCU without CAN controller MB96F615ABPMC-GS-UJE2 |
| Rev.*D | | |
| - | Marketing Part Numbers changed from an MB prefix to a CY prefix. | |

| Page | Section | Change Results |
|------|--------------------------|--|
| 58 | 16. Ordering Information | <p>Revised Marketing Part Numbers as follows:</p> <p>Before)</p> <p>MCU with CAN Controller MB96F612RBPMC-GSE1 MB96F612RBPMC-GS-UJE1 MB96F612RBPMC-GSE2 MB96F612RBPMC-GS-UJE2 MB96F612RBPMC-GTE1 MB96F613RBPMC-GSE1 MB96F613RBPMC-GS-UJE1 MB96F613RBPMC-GSE2 MB96F613RBPMC-GS-UJE2 MB96F613RBPMC-GTE1 MB96F615RBPMC-GSE1 MB96F615RBPMC-GS-UJE1 MB96F615RBPMC-GSE2 MB96F615RBPMC-GS-UJE2 MB96F615RBPMC-GTE1</p> <p>MCU without CAN Controller MB96F612ABPMC-GSE1 MB96F612ABPMC-GS-UJE1 MB96F612ABPMC-GSE2 MB96F612ABPMC-GS-UJE2 MB96F612ABPMC-GTE1 MB96F613ABPMC-GSE1 MB96F613ABPMC-GS-UJE1 MB96F613ABPMC-GSE2 MB96F613ABPMC-GS-UJE2 MB96F613ABPMC-GTE1 MB96F615ABPMC-GSE1 MB96F615ABPMC-GS-UJE1 MB96F615ABPMC-GSE2 MB96F615ABPMC-GTE1</p> |
| 58 | 16. Ordering Information | <p>After)</p> <p>MCU with CAN Controller CY96F612RBPMC-GS-UJE1 CY96F612RBPMC-GS-UJE2 CY96F613RBPMC-GS-UJE1 CY96F613RBPMC-GS-UJE2 CY96F613RBPMC-GS-UJERE2 CY96F615RBPMC-GS-UJE1 CY96F615RBPMC-GS-UJE2 CY96F615RBPMC-GS-UJERE2</p> <p>MCU without CAN Controller CY96F612ABPMC-GS-UJE1 CY96F612ABPMC-GS-UJE2 CY96F613ABPMC-GS-UJE1 CY96F613ABPMC-GS-UJE2 CY96F615ABPMC-GS-UJE1</p> |

Document History

Document Title: CY96610 Series, F²MC, 16FX, 16-bit Proprietary Microcontroller
Document Number: 002-04709

| Revision | ECN | Orig. of Change | Submission Date | Description of Change |
|----------|---------|-----------------|-----------------|--|
| ** | — | KSUN | 01/31/2014 | Migrated to Cypress and assigned document number 002-04709. No change to document contents or format. |
| *A | 5146534 | KSUN | 02/29/2016 | Updated to Cypress template |
| *B | 5735123 | KUME | 05/15/2017 | Updated the Ordering Information and the Package Dimension For details, please see 18. Major Changes. |
| *C | 5809040 | MIYH | 07/11/2017 | Updated the Ordering Information For details, please see 18. Major Changes. |
| *D | 5978072 | MIYH | 11/30/2017 | Revised the following items: Marketing Part Numbers changed from an MB prefix to a CY prefix. 16. Ordering Information For details, please see 18. Major Changes. |

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